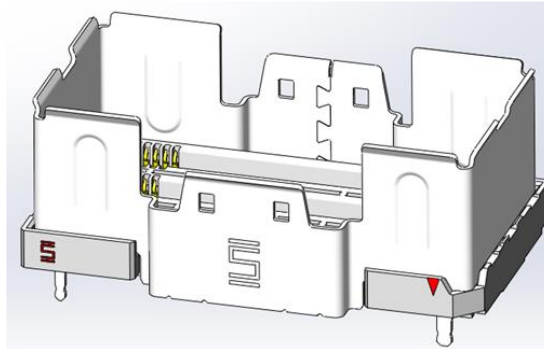
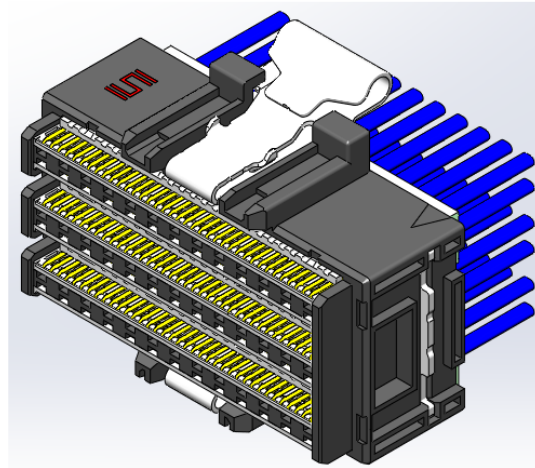




Project Number: Design Qualification Test Report	Tracking Code: 3411480_Report_Rev_1
Requested by: Roy Luo	Date: 9/21/2022
Part #: ARP6-DP-008-04-06.0-B-L-L/APF6-025-03.5-L-04-2-L-TR HDR-225218-01(ARP6 SINGLE END)/APF6-037-03.5-L-06-2-L-TR	
Part description: ARP6/APF6	Tech: Kason He and Tony Wagoner
Test Start: 7/15/2022	Test Completed: 8/23/2022



DESIGN QUALIFICATION TEST REPORT

ARP6/APF6

ARP6-DP-008-04-06.0-B-L-L/APF6-025-03.5-L-04-2-L-TR

HDR-225218-01(ARP6 SINGLE END)/APF6-037-03.5-L-06-2-L-TR

Tracking Code:3411480_Report_Rev_1

Part #: ARP6-DP-008-04-06.0-B-L-L/APF6-025-03.5-L-04-2-L-TR
HDR-225218-01(ARP6 SINGLE END)/APF6-037-03.5-L-06-2-L-TR

Part description: ARP6/APF6

REVISION HISTORY

DATA	REV.NUM.	DESCRIPTION	ENG
9/21/2022	1	Initial Issue	KH

CERTIFICATION

All instruments and measuring equipment were calibrated to National Institute for Standards and Technology (NIST) traceable standards according to ISO 10012-1 and ANSI/NCSL 2540-1, as applicable.

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SCOPE

To perform the following tests: Design Qualification test. Please see test plan.

APPLICABLE DOCUMENTS

Standards: EIA Publication 364

TEST SAMPLES AND PREPARATION

- 1) All materials were manufactured in accordance with the applicable product specification.
- 2) All test samples were identified and encoded to maintain traceability throughout the test sequences.
- 3) After soldering, the parts to be used for LLCR and DWV/IR testing were cleaned according to TLWI-0001.
- 4) Either an automated cleaning procedure or an ultrasonic cleaning procedure may be used.
- 5) The automated procedure is used with aqueous compatible soldering materials.
- 6) Parts not intended for testing LLCR and DWV/IR are visually inspected and cleaned if necessary.
- 7) Any additional preparation will be noted in the individual test sequences.
- 8) Solder Information: Lead free
- 9) Samtec Test PCBs used: PCB-112160-TST/PCB-112102-TST/PCB-112103-TST.

FLOWCHARTS**Gas Tight**Group 1

HDR-225218-01
APF6-037-03.5-L-06-2-L-TR
8 Assemblies

Step Description

1. LLCR (2)
2. Gas Tight (1)
3. LLCR (2)
Max Delta = 15 mOhm

(1) Gas Tight = EIA-364-36

(2) LLCR = EIA-364-23
Open Circuit Voltage = 20 mV Max
Test Current = 100 mA Max

Normal ForceGroup 1

APF6-025-03.5-L-04-2-L-TR

8 Contacts Minimum
Signal Without Thermals

Step Description

1. Contact Gaps
2. Normal Force (1)
Expected Force at Max Deflection = 71 g
Deflection = 0.011 "

Group 2

APF6-025-03.5-L-04-2-L-TR

8 Contacts Minimum
Signal With Thermals

Step Description

1. Contact Gaps
2. Thermal Age (2) - Non Standard
3. Contact Gaps
4. Normal Force (1)
Expected Force at Max Deflection = 69 g
Deflection = 0.011 "

(1) Normal Force = EIA-364-04

(2) Thermal Age = EIA-364-17
Test Condition = 4 (105°C)
Time Condition = B (250 Hours)

FLOWCHARTS Continued**Thermal Aging**Group 1

HDR-225218-01

APF6-037-03.5-L-06-2-L-TR

8 Assemblies

Step	Description
1.	Contact Gaps
2.	Mating/Unmating Force ⁽²⁾
3.	LLCR ⁽¹⁾
4.	Thermal Age ⁽³⁾ - Non Standard
5.	LLCR ⁽¹⁾ Max Delta = 15 mOhm
6.	Mating/Unmating Force ⁽²⁾
7.	Contact Gaps

(1) LLCR = EIA-364-23

Open Circuit Voltage = 20 mV Max

Test Current = 100 mA Max

(2) Mating/Unmating Force = EIA-364-13

(3) Thermal Age = EIA-364-17

Test Condition = 4 (105°C)

Time Condition = B (250 Hours)

FLOWCHARTS Continued**Mating/Unmating/Durability****Smallest Pin Count**

Group 1
ARP6-DP-008-04-06.0-B-L-L
APF6-025-03.5-L-04-2-L-TR
8 Assemblies

Step	Description
1.	Contact Gaps
2.	Mating/Unmating Force ⁽³⁾
3.	Cycles Quantity = 25 Cycles
4.	Mating/Unmating Force ⁽³⁾
5.	Cycles Quantity = 25 Cycles
6.	Mating/Unmating Force ⁽³⁾
7.	Cycles Quantity = 25 Cycles
8.	Mating/Unmating Force ⁽³⁾
9.	Cycles Quantity = 25 Cycles
10.	Mating/Unmating Force ⁽³⁾
11.	Contact Gaps

Largest Pin Count

Group 2
HDR-225218-01
APF6-037-03.5-L-06-2-L-TR
8 Assemblies

Step	Description
1.	Contact Gaps
2.	LLCR ⁽²⁾
3.	Mating/Unmating Force ⁽³⁾
4.	Cycles Quantity = 25 Cycles
5.	Mating/Unmating Force ⁽³⁾
6.	Cycles Quantity = 25 Cycles
7.	Mating/Unmating Force ⁽³⁾
8.	Cycles Quantity = 25 Cycles
9.	Mating/Unmating Force ⁽³⁾
10.	Cycles Quantity = 25 Cycles
11.	Mating/Unmating Force ⁽³⁾
12.	Contact Gaps
13.	LLCR ⁽²⁾ Max Delta = 15 mOhm
14.	Thermal Shock ⁽⁴⁾ - Non Standard
15.	LLCR ⁽²⁾ Max Delta = 15 mOhm
16.	Humidity ⁽¹⁾
17.	LLCR ⁽²⁾ Max Delta = 15 mOhm
18.	Mating/Unmating Force ⁽³⁾

- (1) Humidity = EIA-364-31
Test Condition = B (240 Hours)
Test Method = III (+25°C to +65°C @ 90% RH to 98% RH)
Test Exceptions: ambient pre-condition and delete steps 7a and 7b
- (2) LLCR = EIA-364-23
Open Circuit Voltage = 20 mV Max
Test Current = 100 mA Max
- (3) Mating/Unmating Force = EIA-364-13
- (4) Thermal Shock = EIA-364-32
Exposure Time at Temperature Extremes = 1/2 Hour
Method A, Test Condition = I (-55°C to +85°C)
Test Duration = A-3 (100 Cycles)

FLOWCHARTS Continued**IR/DWV****Pin-to-Pin**

<u>Group 1</u> HDR-225218-01 APF6-037-03.5-L-06-2-L-TR 2 Assemblies		<u>Group 2</u> HDR-225218-01 2 Assemblies		<u>Group 3</u> APF6-037-03.5-L-06-2-L-TR 2 Assemblies		<u>Group 4</u> HDR-225218-01 APF6-037-03.5-L-06-2-L-TR 2 Assemblies	
Step	Description	Step	Description	Step	Description	Step	Description
1.	DWV Breakdown (2)	1.	DWV Breakdown (2)	1.	DWV Breakdown (2)	1.	IR (4)
						2.	DWV at Test Voltage (1)
						3.	Thermal Shock (5)
						4.	IR (4)
						5.	DWV at Test Voltage (1)
						6.	Humidity (3)
						7.	IR (4)
						8.	DWV at Test Voltage (1)

Row-to-Row

<u>Group 5</u> HDR-225218-01 APF6-037-03.5-L-06-2-L-TR 2 Assemblies		<u>Group 6</u> HDR-225218-01 2 Assemblies		<u>Group 7</u> APF6-037-03.5-L-06-2-L-TR 2 Assemblies		<u>Group 8</u> HDR-225218-01 APF6-037-03.5-L-06-2-L-TR 2 Assemblies	
Step	Description	Step	Description	Step	Description	Step	Description
1.	DWV Breakdown (2)	1.	DWV Breakdown (2)	1.	DWV Breakdown (2)	1.	IR (4)
						2.	DWV at Test Voltage (1)
						3.	Thermal Shock (5)
						4.	IR (4)
						5.	DWV at Test Voltage (1)
						6.	Humidity (3)
						7.	IR (4)
						8.	DWV at Test Voltage (1)

FLOWCHARTS Continued**Pin-to-Ground**

<u>Group 9</u> HDR-225218-01 APF6-037-03.5-L-06-2-L-TR 2 Assemblies		<u>Group 10</u> HDR-225218-01 2 Assemblies		<u>Group 11</u> APF6-037-03.5-L-06-2-L-TR 2 Assemblies		<u>Group 12</u> HDR-225218-01 APF6-037-03.5-L-06-2-L-TR 2 Assemblies	
Step	Description	Step	Description	Step	Description	Step	Description
1.	DWV Breakdown (2)	1.	DWV Breakdown (2)	1.	DWV Breakdown (2)	1.	IR (4)
						2.	DWV at Test Voltage (1)
						3.	Thermal Shock (5)
						4.	IR (4)
						5.	DWV at Test Voltage (1)
						6.	Humidity (3)
						7.	IR (4)
						8.	DWV at Test Voltage (1)

Pin-to-Closest Metallic Hardware

<u>Group 13</u> HDR-225218-01 APF6-037-03.5-L-06-2-L-TR 2 Assemblies		<u>Group 14</u> HDR-225218-01 2 Assemblies		<u>Group 15</u> APF6-037-03.5-L-06-2-L-TR 2 Assemblies		<u>Group 16</u> HDR-225218-01 APF6-037-03.5-L-06-2-L-TR 2 Assemblies	
Step	Description	Step	Description	Step	Description	Step	Description
1.	DWV Breakdown (2)	1.	DWV Breakdown (2)	1.	DWV Breakdown (2)	1.	IR (4)
						2.	DWV at Test Voltage (1)
						3.	Thermal Shock (5)
						4.	IR (4)
						5.	DWV at Test Voltage (1)
						6.	Humidity (3)
						7.	IR (4)
						8.	DWV at Test Voltage (1)

- (1) DWV at Test Voltage = EIA-364-20
Test Condition = 1 (Sea Level)
DWV test voltage is equal to 75% of the lowest breakdown voltage
Test voltage applied for 60 seconds
- (2) DWV Breakdown = EIA-364-20
Test Condition = 1 (Sea Level)
DWV test voltage is equal to 75% of the lowest breakdown voltage
Test voltage applied for 60 seconds
- (3) Humidity = EIA-364-31
Test Condition = B (240 Hours)
Test Method = III (+25°C to +65°C @ 90% RH to 98% RH)
Test Exceptions: ambient pre-condition and delete steps 7a and 7b
- (4) IR = EIA-364-21
Test Condition = 500 Vdc, 2 Minutes Max
- (5) Thermal Shock = EIA-364-32
Exposure Time at Temperature Extremes = 1/2 Hour
Method A, Test Condition = I (-55°C to +85°C)
Test Duration = A-3 (100 Cycles)

FLOWCHARTS Continued**Current Carrying Capacity**Group 1

ARP6-DP-012-06-12.0-B-L-L
APF6-037-03.5-L-06-2-L-TR
6 Pins Powered
Signal

Step	Description
1.	CCC ⁽²⁾ Rows = 6 Number of Positions = 1

Group 2

ARP6-DP-012-06-12.0-B-L-L
APF6-037-03.5-L-06-2-L-TR
12 Pins Powered
Signal

Step	Description
1.	CCC ⁽²⁾ Rows = 6 Number of Positions = 2

Group 3

ARP6-DP-012-06-12.0-B-L-L
APF6-037-03.5-L-06-2-L-TR
18 Pins Powered
Signal

Step	Description
1.	CCC ⁽²⁾ Rows = 6 Number of Positions = 3

Group 4

ARP6-DP-012-06-12.0-B-L-L
APF6-037-03.5-L-06-2-L-TR
24 Pins Powered
Signal

Step	Description
1.	CCC ⁽²⁾ Rows = 6 Number of Positions = 4

Group 5

ARP6-DP-012-06-12.0-B-L-L
APF6-037-03.5-L-06-2-L-TR
144 Pins Powered
Signal

Step	Description
1.	CCC ⁽²⁾ Rows = 6 Number of Positions = 24

Group 6

ARP6-DP-012-06-12.0-B-L-L
APF6-037-03.5-L-06-2-L-TR
6 Pins Powered
Ground

Step	Description
1.	CCC ⁽²⁾ Rows = 6 Number of Positions = 1

Group 7

ARP6-DP-012-06-12.0-B-L-L
APF6-037-03.5-L-06-2-L-TR
All Power

Step	Description
1.	CCC - All Power ⁽¹⁾

(1) CCC - All Power = EIA-364-70

Method 2, Temperature Rise Versus Current Curve

(TIN PLATING) - Tabulate calculated current at RT, 65°C, 75°C and 95°C after derating 20% and based on 105°C

(GOLD PLATING) - Tabulate calculated current at RT, 85°C, 95°C and 115°C after derating 20% and based on 125°C

(2) CCC = EIA-364-70

Method 2, Temperature Rise Versus Current Curve

(TIN PLATING) - Tabulate calculated current at RT, 65°C, 75°C and 95°C after derating 20% and based on 105°C

(GOLD PLATING) - Tabulate calculated current at RT, 85°C, 95°C and 115°C after derating 20% and based on 125°C

FLOWCHARTS Continued**Mechanical Shock/Random Vibration/LLCR**Group 1

HDR-225218-01

APF6-037-03.5-L-06-2-L-TR

8 Assemblies

Step	Description
1.	LLCR ⁽¹⁾
2.	Mechanical Shock ⁽²⁾ - Non Standard
3.	Random Vibration ⁽³⁾ - Non Standard
4.	LLCR ⁽¹⁾ Max Delta = 15 mOhm

(1) LLCR = EIA-364-23

Open Circuit Voltage = 20 mV Max

Test Current = 100 mA Max

(2) Mechanical Shock = EIA-364-27

Test Condition = C (100 G Peak, 6 milliseconds, Half Sine)

Number of Shocks = 3 Per Direction, Per Axis, 18 Total

(3) Random Vibration = EIA-364-28

Condition = VB (7.56 gRMS Average, 2 Hours/Axis)

Mechanical Shock/Random Vibration/Event DetectionGroup 1

HDR-225218-01

APF6-037-03.5-L-06-2-L-TR

60 Points

Step	Description
1.	Nanosecond Event Detection (Mechanical Shock) ⁽¹⁾ - Non Standard
2.	Nanosecond Event Detection (Random Vibration) ⁽²⁾ - Non Standard

(1) Nanosecond Event Detection (Mechanical Shock)

Use EIA-364-87 for Nanosecond Event Detection:

Test Condition = F (50 nanoseconds at 10 ohms)

Use EIA-364-27 for Mechanical Shock:

Test Condition = C (100 G Peak, 6 milliseconds, Half Sine)

Number of Shocks = 3 Per Direction, Per Axis, 18 Total

(2) Nanosecond Event Detection (Random Vibration)

Use EIA-364-87 for Nanosecond Event Detection:

Test Condition = F (50 nanoseconds at 10 ohms)

Use EIA-364-28 for Random Vibration:

Condition = VB (7.56 gRMS Average, 2 Hours/Axis)

FLOWCHARTS Continued**Cable Pull****Smallest Pin Count**Group 1

ARP6-DP-008-04-12.0-B-L-L

APF6-025-03.5-L-04-2-L-TR

5 Assemblies

0 Degrees

Step Description

1. Cable Pull (1)

Group 2

ARP6-DP-008-04-12.0-B-L-L

APF6-025-03.5-L-04-2-L-TR

5 Assemblies

90 Degrees

Step Description

1. Cable Pull (1)

Largest Pin CountGroup 3

ARP6-DP-012-06-12.0-B-L-L

APF6-037-03.5-L-06-2-L-TR

5 Assemblies

0 Degrees

Step Description

1. Cable Pull (1)

Group 4

ARP6-DP-012-06-12.0-B-L-L

APF6-037-03.5-L-06-2-L-TR

5 Assemblies

90 Degrees

Step Description

1. Cable Pull (1)

(1) Cable Pull = EIA-364-38

Measure and Record Force Required to Failure

Failure = Discontinuity >1 microsecond at 10 ohms

FLOWCHARTS Continued**Cable Flex****Smallest Pin Count**Group 1

ARP6-DP-008-04-16.0-B-L-L

APF6-025-03.5-L-04-2-L-TR

8 Assemblies

Step	Description
1.	IR ⁽³⁾ - Non Standard
2.	DWV at Test Voltage ⁽²⁾
3.	Cable Flex ⁽¹⁾
4.	Visual Inspection
5.	IR ⁽³⁾ - Non Standard
6.	DWV at Test Voltage ⁽²⁾

Largest Pin CountGroup 2

ARP6-DP-012-06-16.0-B-L-L

APF6-037-03.5-L-06-2-L-TR

8 Assemblies

Step	Description
1.	IR ⁽³⁾ - Non Standard
2.	DWV at Test Voltage ⁽²⁾
3.	Cable Flex ⁽¹⁾
4.	Visual Inspection
5.	IR ⁽³⁾ - Non Standard
6.	DWV at Test Voltage ⁽²⁾

(1) Cable Flex = EIA-364-41

Circular Jacket Cable - to be tested 90° each direction (180° total)

Flat Cable - to be tested 70° each direction (140° total)

Monitor continuity during flex testing

Failure = Discontinuity >1 microsecond at 10 ohms

(2) DWV at Test Voltage = EIA-364-20

Test Condition = 1 (Sea Level)

DWV test voltage is equal to 75% of the lowest breakdown voltage

Test voltage applied for 60 seconds

(3) IR = EIA-364-21

Test Condition = 500 Vdc, 2 Minutes Max

ATTRIBUTE DEFINITIONS

The following is a brief, simplified description of attributes.

THERMAL:

- 1) EIA-364-17, *Temperature Life with or without Electrical Load Test Procedure for Electrical Connectors*.
- 2) Test Condition at 105° C.
- 3) Test Time Condition B for 250 hours.
- 4) All test samples are pre-conditioned at ambient.
- 5) All test samples are exposed to environmental stressing in the mated condition.

THERMAL SHOCK:

- 1) EIA-364-32, *Thermal Shock (Temperature Cycling) Test Procedure for Electrical Connectors*.
- 2) Test Condition 1: -55°C to +85°C
- 3) Test Time: ½ hour dwell at each temperature extreme
- 4) Number of Cycles: 100
- 5) All test samples are pre-conditioned at ambient.
- 6) All test samples are exposed to environmental stressing in the mated condition.

HUMIDITY:

- 1) Reference document: EIA-364-31, *Humidity Test Procedure for Electrical Connectors*.
- 2) Test Condition B, 240 Hours.
- 3) Method III, +25° C to + 65° C, 90% to 98% Relative Humidity excluding sub-cycles 7a and 7b.
- 4) All samples are pre-conditioned at ambient.
- 5) All test samples are exposed to environmental stressing in the mated condition.

MATING/UNMATING:

- 1) Reference document: EIA-364-13, *Mating and Unmating Forces Test Procedure for Electrical Connectors*.
- 2) The full insertion position was to within 0.003” to 0.004” of the plug bottoming out in the receptacle to prevent damage to the system under test.
- 3) One of the mating parts is secured to a floating X-Y table to prevent damage during cycling.

MECHANICAL SHOCK (Specified Pulse):

- 1) Reference document: EIA-364-27, *Mechanical Shock Test Procedure for Electrical Connectors*
- 2) Test Condition G
- 3) Peak Value: 100 G
- 4) Duration: 6 Milliseconds
- 5) Wave Form: Half Sine
- 6) Velocity: 12.3 ft/s
- 7) Number of Shocks: 3 Shocks / Direction, 3 Axis (18 Total)

VIBRATION:

- 1) Reference document: EIA-364-28, *Vibration Test Procedure for Electrical Connectors*
- 2) Test Condition V, Letter B
- 3) Power Spectral Density: 0.04 G² / Hz
- 4) G ‘RMS’: 7.56
- 5) Frequency: 50 to 2000 Hz
- 6) Duration: 2.0 Hours per axis (3 axis total)

NANOSECOND-EVENT DETECTION:

- 1) Reference document: EIA-364-87, *Nanosecond-Event Detection for Electrical Connectors*
- 2) Prior to test, the samples were characterized to assure the low nanosecond event being monitored will trigger the detector.
- 3) After characterization it was determined the test samples could be monitored for 50 nanosecond events

ATTRIBUTE DEFINITIONS Continued

The following is a brief, simplified description of attributes.

NORMAL FORCE (FOR CONTACTS TESTED IN THE HOUSING):

- 1) Reference document: EIA-364-04, *Normal Force Test Procedure for Electrical Connectors*.
- 2) The contacts shall be tested in the connector housing.
- 3) If necessary, a "window" shall be made in the connector body to allow a probe to engage and deflect the contact at the same attitude and distance (plus 0.05 mm [0.002"]) as would occur in actual use.
- 4) The connector housing shall be placed in a holding fixture that does not interfere with or otherwise influence the contact force or deflection.
- 5) Said holding fixture shall be mounted on a floating, adjustable, X-Y table on the base of the Dillon TC², computer controlled test stand with a deflection measurement system accuracy of 5.0 μm (0.0002").
- 6) The nominal deflection rate shall be 5 mm (0.2")/minute.
- 7) Unless otherwise noted a minimum of five contacts shall be tested.
- 8) The force/deflection characteristic to load and unload each contact shall be repeated five times.
- 9) The system shall utilize the TC² software in order to acquire and record the test data.
- 10) The permanent set of each contact shall be measured within the TC² software.
- 11) The acquired data shall be graphed with the deflection data on the X-axis and the force data on the Y-axis and a print out will be stored with the Tracking Code paperwork.

LLCR:

- 1) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 2) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 3) The following guidelines are used to categorize the changes in LLCR as a result from stressing
 - a. <= +5.0 mOhms: -----Stable
 - b. +5.1 to +10.0 mOhms:-----Minor
 - c. +10.1 to +15.0 mOhms: -----Acceptable
 - d. +15.1 to +50.0 mOhms: -----Marginal
 - e. +50.1 to +1000 mOhms: -----Unstable
 - f. >+1000 mOhms:-----Open Failure

ATTRIBUTE DEFINITIONS Continued

The following is a brief, simplified description of attributes.

GAS TIGHT:

To provide method for evaluating the ability of the contacting surfaces in preventing penetration of harsh vapors which might lead to oxide formation that may degrade the electrical performance of the contact system.

- 1) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 2) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 3) The following guidelines are used to categorize the changes in LLCR as a result from stressing
 - a. $\leq +5.0$ mOhms:-----Stable
 - b. $+5.1$ to $+10.0$ mOhms:-----Minor
 - c. $+10.1$ to $+15.0$ mOhms:-----Acceptable
 - d. $+15.1$ to $+50.0$ mOhms:-----Marginal
 - e. $+50.1$ to $+1000$ mOhms:-----Unstable
 - f. $>+1000$ mOhms:-----Open Failure
- 4) Procedure:
 - a. Reference document: EIA-364-36, *Test Procedure for Determination of Gas-Tight Characteristics for Electrical Connectors, Sockets and/or Contact Systems*.
 - b. Test Conditions:
 - i. Class II--- Mated pairs of contacts assembled to their plastic housings.
 - ii. Reagent grade Nitric Acid shall be used of sufficient volume to saturate the test chamber
 - iii. The ratio of the volume of the test chamber to the surface area of the acid shall be 10:1.
 - iv. The chamber shall be saturated with the vapor for at least 15 minutes before samples are added.
 - v. Exposure time, 55 to 65 minutes.
 - vi. The samples shall be no closer to the chamber walls than 1 inches and no closer to the surface of the acid than 3 inches.
 - vii. The samples shall be dried after exposure for a minimum of 1 hour.
 - viii. Drying temperature 50° C
 - ix. The final LLCR shall be conducted within 1 hour after drying.

ATTRIBUTE DEFINITIONS Continued

The following is a brief, simplified description of attributes.

INSULATION RESISTANCE (IR):

To determine the resistance of insulation materials to leakage of current through or on the surface of these materials when a DC potential is applied.

- 1) PROCEDURE:
 - a. Reference document: EIA-364-21, *Insulation Resistance Test Procedure for Electrical Connectors*.
 - b. Test Conditions:
 - i. Between Adjacent Contacts or Signal-to-Ground
 - ii. Electrification Time 2.0 minutes
 - iii. Test Voltage (500 VDC) corresponds to calibration settings for measuring resistances.
- 2) MEASUREMENTS:
- 3) When the specified test voltage is applied (VDC), the insulation resistance shall not be less than 1000 megohms.

DIELECTRIC WITHSTANDING VOLTAGE (DWV):

To determine if the sockets can operate at its rated voltage and withstand momentary over potentials due to switching, surges, and other similar phenomenon. Separate samples are used to evaluate the effect of environmental stresses so not to influence the readings from arcing that occurs during the measurement process.

- 1) PROCEDURE:
 - a. Reference document: EIA-364-20, *Withstanding Voltage Test Procedure for Electrical Connectors*.
 - b. Test Conditions:
 - i. Between Adjacent Contacts or Signal-to-Ground
 - ii. Barometric Test Condition 1
 - iii. Rate of Application 500 V/Sec
 - iv. Test Voltage (VAC) until breakdown occurs
- 2) MEASUREMENTS/CALCULATIONS
 - a. The breakdown voltage shall be measured and recorded.
 - b. The dielectric withstanding voltage shall be recorded as 75% of the minimum breakdown voltage.
 - c. The working voltage shall be recorded as one-third (1/3) of the dielectric withstanding voltage (one-fourth of the breakdown voltage).

ATTRIBUTE DEFINITIONS Continued

The following is a brief, simplified description of attributes.

TEMPERATURE RISE (Current Carrying Capacity, CCC):

- 1) EIA-364-70, *Temperature Rise versus Current Test Procedure for Electrical Connectors and Sockets*.
- 2) When current passes through a contact, the temperature of the contact increases as a result of I^2R (resistive) heating.
- 3) The number of contacts being investigated plays a significant part in power dissipation and therefore temperature rise.
- 4) The size of the temperature probe can affect the measured temperature.
- 5) Copper traces on PC boards will contribute to temperature rise:
 - a. Self-heating (resistive)
 - b. Reduction in heat sink capacity affecting the heated contacts
- 6) A de-rating curve, usually 20%, is calculated.
- 7) Calculated de-rated currents at four temperature points are reported:
 - a. Ambient
 - b. 85° C
 - c. 95° C
 - d. 115° C
- 8) Typically, neighboring contacts (in close proximity to maximize heat buildup) are energized.
- 9) The thermocouple (or temperature measuring probe) will be positioned at a location to sense the maximum temperature in the vicinity of the heat generation area.
- 10) A computer program, *TR 803.exe*, ensures accurate stability for data acquisition.
- 11) Hook-up wire cross section is larger than the cross section of any connector leads/PC board traces, jumpers, etc.
- 12) Hook-up wire length is longer than the minimum specified in the referencing standard.

ATTRIBUTE DEFINITIONS Continued

The following is a brief, simplified description of attributes.

CABLE PULL:

- 1) Secure cable near center and pull-on connector
 - a. At 0°, in-line with cable
 - b. At 90°, in-line with cable



Fig. 1
0° Connector pull

CABLE DURABILITY:

- 1) Oscillate and monitor electrical continuity for open circuit indication.
 - a. $\pm 70^\circ$ Flex Mode, bend up to 500 cycles. load on cable end.

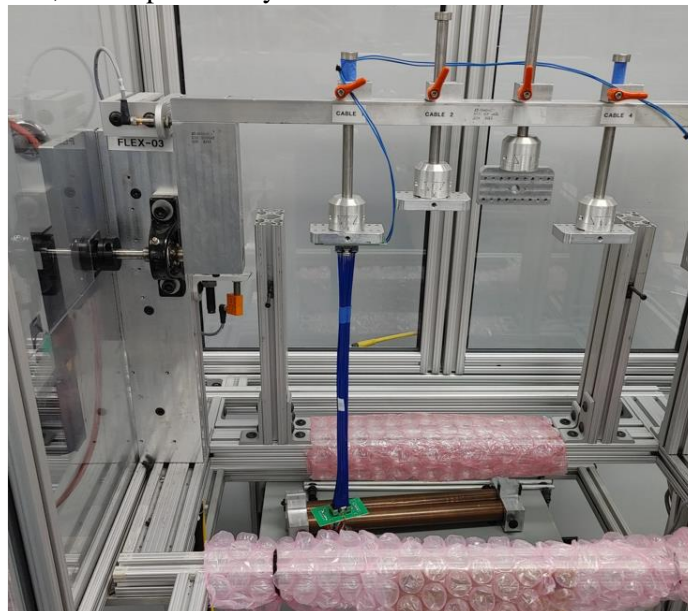


Fig. 2
(Setup picture)

RESULTS

Temperature Rise, CCC at a 20% de-rating

Signal Pin

- CCC for a 30°C Temperature Rise-----1.3 A per contact with 6 contacts (6x1) powered.
- CCC for a 30°C Temperature Rise-----0.9 A per contact with 12 contacts (6x2) powered.
- CCC for a 30°C Temperature Rise-----0.8 A per contact with 18 contacts (6x3) powered.
- CCC for a 30°C Temperature Rise-----0.7 A per contact with 24 contacts (6x4) powered.
- CCC for a 30°C Temperature Rise-----0.3 A per contact with 144 contacts (6x24) powered.

Ground Pin

- CCC for a 30°C Temperature Rise-----8.7 A 6 ground tied together with all contact powered.

Ground pin and Signal pin

- CCC for a 30°C Temperature Rise-----8.0 A 6 adjacent ground tied to together and signal contacts powered @ 1/2 rated current.

Mating – Unmating Forces

Thermal Aging Group

- Initial
 - Mating
 - Min -----11.74 lbs
 - Max-----13.55 lbs
 - Unmating
 - Min ----- 5.61 lbs
 - Max----- 6.66 lbs
- After Thermal
 - Mating
 - Min ----- 7.61 lbs
 - Max----- 8.25 lbs
 - Unmating
 - Min ----- 5.48 lbs
 - Max----- 6.44 lbs

RESULTS Continued**Mating – Unmating Forces****Mating-Unmating Durability Group 2 Largest Pin Count**

- **Initial**
 - **Mating**
 - **Min** -----10.56 Lbs
 - **Max** -----12.14 Lbs
 - **Unmating**
 - **Min** ----- 4.71 Lbs
 - **Max** ----- 6.61 Lbs
- **After 25 Cycles**
 - **Mating**
 - **Min** -----10.52 Lbs
 - **Max** -----12.37 Lbs
 - **Unmating**
 - **Min** ----- 5.22 Lbs
 - **Max** ----- 7.32 Lbs
- **After 50 Cycles**
 - **Mating**
 - **Min** -----10.68 Lbs
 - **Max** -----12.27 Lbs
 - **Unmating**
 - **Min** ----- 5.72 Lbs
 - **Max** ----- 7.89 Lbs
- **After 75 Cycles**
 - **Mating**
 - **Min** -----10.76 Lbs
 - **Max** -----12.23 Lbs
 - **Unmating**
 - **Min** ----- 6.21 Lbs
 - **Max** ----- 8.20 Lbs
- **After 100 Cycles**
 - **Mating**
 - **Min** -----10.88 Lbs
 - **Max** -----12.27 Lbs
 - **Unmating**
 - **Min** ----- 6.51 Lbs
 - **Max** ----- 8.30 Lbs
- **Humidity**
 - **Mating**
 - **Min** ----- 8.29 Lbs
 - **Max** ----- 9.92 Lbs
 - **Unmating**
 - **Min** ----- 4.84 Lbs
 - **Max** ----- 7.00 Lbs

RESULTS Continued**Mating-Unmating Basic Group 1 Smallest Pin Count**

- **Initial**
 - **Mating**
 - **Min** ----- 5.12 Lbs
 - **Max** ----- 5.76 Lbs
 - **Unmating**
 - **Min** ----- 2.49 Lbs
 - **Max** ----- 3.05 Lbs
- **After 25 Cycles**
 - **Mating**
 - **Min** ----- 5.44 Lbs
 - **Max** ----- 6.23 Lbs
 - **Unmating**
 - **Min** ----- 2.82 Lbs
 - **Max** ----- 3.52 Lbs
- **After 50 Cycles**
 - **Mating**
 - **Min** ----- 5.44 Lbs
 - **Max** ----- 6.29 Lbs
 - **Unmating**
 - **Min** ----- 3.17 Lbs
 - **Max** ----- 3.85 Lbs
- **After 75 Cycles**
 - **Mating**
 - **Min** ----- 5.50 Lbs
 - **Max** ----- 6.39 Lbs
 - **Unmating**
 - **Min** ----- 3.37 Lbs
 - **Max** ----- 4.07 Lbs
- **After 100 Cycles**
 - **Mating**
 - **Min** ----- 5.51 Lbs
 - **Max** ----- 6.44 Lbs
 - **Unmating**
 - **Min** ----- 3.12 Lbs
 - **Max** ----- 4.27 Lbs

RESULTS Continued**Normal Force at 0.0098 inches deflection****C-481**

- **Initial**
 - **Min** -----62.60 gf **Set** ---- 0.0007 inch
 - **Max** -----65.60 gf **Set** ---- 0.0009 inch
- **Thermal**
 - **Min** -----31.20 gf **Set** ---- 0.0029 inch
 - **Max** -----38.10 gf **Set** ---- 0.0035 inch

C-482

- **Initial**
 - **Min** -----49.20 gf **Set** ---- 0.0002 inch
 - **Max** -----54.00 gf **Set** ---- 0.0009 inch
- **Thermal**
 - **Min** -----32.80 gf **Set** ---- 0.0018 inch
 - **Max** -----39.10 gf **Set** ---- 0.0025 inch

Cable Pull force**Smallest Pin Count**

- **0° Pull**
 - **Min** -----52.20 lbs
 - **Max** -----58.76 lbs
- **90° Pull**
 - **Min** -----28.67 lbs
 - **Max** -----33.53 lbs

Largest Pin Count

- **0° Pull**
 - **Min** -----41.67 lbs
 - **Max** -----44.11 lbs
- **90° Pull**
 - **Min** -----43.09 lbs
 - **Max** -----45.78 lbs

RESULTS Continued**Insulation Resistance minimums, IR****Pin to Pin**• **Initial**

- Mated-----45000 Meg Ω ----- Passed
- Unmated -----45000 Meg Ω ----- Passed

• **Thermal Shock**

- Mated-----45000 Meg Ω ----- Passed
- Unmated -----45000Meg Ω ----- Passed

• **Humidity**

- Mated-----45000 Meg Ω ----- Passed
- Unmated -----45000 Meg Ω ----- Passed

Row to Row• **Initial**

- Mated-----45000 Meg Ω ----- Passed
- Unmated -----45000 Meg Ω ----- Passed

• **Thermal Shock**

- Mated-----45000 Meg Ω ----- Passed
- Unmated -----45000Meg Ω ----- Passed

• **Humidity**

- Mated-----45000 Meg Ω ----- Passed
- Unmated -----45000 Meg Ω ----- Passed

Pin to Ground• **Initial**

- Mated-----45000 Meg Ω ----- Passed
- Unmated -----45000 Meg Ω ----- Passed

• **Thermal Shock**

- Mated-----45000 Meg Ω ----- Passed
- Unmated -----45000Meg Ω ----- Passed

• **Humidity**

- Mated-----45000 Meg Ω ----- Passed
- Unmated -----45000 Meg Ω ----- Passed

Pin to Closest Metallic Hardware• **Initial**

- Mated-----45000 Meg Ω ----- Passed
- Unmated -----45000 Meg Ω ----- Passed

• **Thermal Shock**

- Mated-----45000 Meg Ω ----- Passed
- Unmated -----45000Meg Ω ----- Passed

• **Humidity**

- Mated-----45000 Meg Ω ----- Passed
- Unmated -----45000 Meg Ω ----- Passed

RESULTS Continued

Dielectric Withstanding Voltage minimums, DWV

- **Minimums**
 - Breakdown Voltage -----658 VAC
 - Test Voltage -----495 VAC
 - Working Voltage -----165 VAC

Pin to Pin

- Initial DWV -----Passed
- Thermal DWV -----Passed
- Humidity DWV -----Passed

Row to Row

- Initial DWV -----Passed
- Thermal DWV -----Passed
- Humidity DWV -----Passed

Pin to Ground

- Initial DWV -----Passed
- Thermal DWV -----Passed
- Humidity DWV -----Passed

Pin to Closest Metallic Hardware

- Initial DWV -----Passed
- Thermal DWV -----Passed
- Humidity DWV -----Passed

RESULTS Continued**Cable Flex:****Insulation Resistance minimums, IR****Smallest Pin Count****Pin to Pin**

- **Initial**
 - Mated-----45000 Meg Ω ----- Passed
- **After 500 flex cycles**
 - Mated-----45000 Meg Ω ----- Passed

Row to Row

- **Initial**
 - Mated-----45000 Meg Ω ----- Passed
- **After 500 flex cycles**
 - Mated-----45000 Meg Ω ----- Passed

Pin to Ground

- **Initial**
 - Mated-----45000 Meg Ω ----- Passed
- **After 500 flex cycles**
 - Mated-----45000 Meg Ω ----- Passed

Pin to Closest Metallic Hardware

- **Initial**
 - Mated-----45000 Meg Ω ----- Passed
- **After 500 flex cycles**
 - Mated-----45000 Meg Ω ----- Passed

Largest Pin Count**Pin to Pin**

- **Initial**
 - Mated-----45000 Meg Ω ----- Passed
- **After 500 flex cycles**
 - Mated-----45000 Meg Ω ----- Passed

Row to Row

- **Initial**
 - Mated-----45000 Meg Ω ----- Passed
- **After 500 flex cycles**
 - Mated-----45000 Meg Ω ----- Passed

Pin to Ground

- **Initial**
 - Mated-----35000 Meg Ω ----- Passed
- **After 500 flex cycles**
 - Mated-----44000 Meg Ω ----- Passed

Pin to Closest Metallic Hardware

- **Initial**
 - Mated-----45000 Meg Ω ----- Passed
- **After 500 flex cycles**
 - Mated-----45000 Meg Ω ----- Passed

RESULTS Continued**Dielectric Withstanding Voltage minimums, DWV**

- Test Voltage -----495 VAC

Smallest Pin Count**Pin to Pin**

- Initial DWV -----Passed
- After 500 Flex cycles DWV -----Passed

Row to Row

- Initial DWV -----Passed
- After 500 Flex cycles DWV -----Passed

Pin to Ground

- Initial DWV -----Passed
- After 500 Flex cycles DWV -----Passed

Pin to Closest Metallic Hardware

- Initial DWV -----Passed
- After 500 Flex cycles DWV -----Passed

Largest Pin Count**Pin to Pin**

- Initial DWV -----Passed
- After 500 Flex cycles DWV -----Passed

Row to Row

- Initial DWV -----Passed
- After 500 Flex cycles DWV -----Passed

Pin to Ground

- Initial DWV -----Passed
- After 500 Flex cycles DWV -----Passed

Pin to Closest Metallic Hardware

- Initial DWV -----Passed
- After 500 Flex cycles DWV -----Passed

RESULTS Continued**LLCR Gas Tight Group (144 signal and 48 ground LLCR test points)****Signal Pin**

- **Initial** -----380.10 mOhms Max
- **Gas Tight**
 - <= +5.0 mOhms----- 96 Points ----- Stable
 - +5.1 to +10.0 mOhms ----- 34 Points ----- Minor
 - +10.1 to +15.0 mOhms ----- 14 Points ----- Acceptable
 - +15.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +1000 mOhms----- 0 Points ----- Unstable
 - >+1000 mOhms----- 0 Points ----- Open Failure

Ground Pin

- **Initial** ----- 26.97 mOhms Max
- **Gas Tight**
 - <= +5.0 mOhms----- 48 Points ----- Stable
 - +5.1 to +10.0 mOhms ----- 0 Points ----- Minor
 - +10.1 to +15.0 mOhms ----- 0 Points ----- Acceptable
 - +15.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +1000 mOhms----- 0 Points ----- Unstable
 - >+1000 mOhms----- 0 Points ----- Open Failure

LLCR Thermal Aging (144 signal and 48 ground LLCR test points)**Signal Pin**

- **Initial** ----- 92.93 mOhms Max
- **Thermal Aging**
 - <= +5.0 mOhms----- 120 Points ----- Stable
 - +5.1 to +10.0 mOhms ----- 20 Points ----- Minor
 - +10.1 to +15.0 mOhms ----- 4 Points ----- Acceptable
 - +15.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +1000 mOhms----- 0 Points ----- Unstable
 - >+1000 mOhms----- 0 Points ----- Open Failure

Ground Pin

- **Initial** ----- 26.82 mOhms Max
- **Thermal Aging**
 - <= +5.0 mOhms----- 48 Points ----- Stable
 - +5.1 to +10.0 mOhms ----- 0 Points ----- Minor
 - +10.1 to +15.0 mOhms ----- 0 Points ----- Acceptable
 - +15.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +1000 mOhms----- 0 Points ----- Unstable
 - >+1000 mOhms----- 0 Points ----- Open Failure

RESULTS Continued**LLCR Mating/Unmating Durability Group (144 signal and 48 ground LLCR test points)****Signal Pin**

- **Initial** -----376.60 mOhms Max
- **Durability, 100 Cycles**
 - <= +5.0 mOhms-----120 Points ----- Stable
 - +5.1 to +10.0 mOhms ----- 24 Points ----- Minor
 - +10.1 to +15.0 mOhms -----0 Points ----- Acceptable
 - +15.1 to +50.0 mOhms -----0 Points ----- Marginal
 - +50.1 to +1000 mOhms-----0 Points ----- Unstable
 - >+1000 mOhms-----0 Points ----- Open Failure
- **Thermal Shock**
 - <= +5.0 mOhms-----135 Points ----- Stable
 - +5.1 to +10.0 mOhms -----7 Points ----- Minor
 - +10.1 to +15.0 mOhms -----2 Points ----- Acceptable
 - +15.1 to +50.0 mOhms -----0 Points ----- Marginal
 - +50.1 to +1000 mOhms-----0 Points ----- Unstable
 - >+1000 mOhms-----0 Points ----- Open Failure
- **Humidity**
 - <= +5.0 mOhms-----125 Points ----- Stable
 - +5.1 to +10.0 mOhms ----- 15 Points ----- Minor
 - +10.1 to +15.0 mOhms -----4 Points ----- Acceptable
 - +15.1 to +50.0 mOhms -----0 Points ----- Marginal
 - +50.1 to +1000 mOhms-----0 Points ----- Unstable
 - >+1000 mOhms-----0 Points ----- Open Failure

Ground Pin

- **Initial** ----- 27.92 mOhms Max
- **Durability, 100 Cycles**
 - <= +5.0 mOhms----- 48 Points ----- Stable
 - +5.1 to +10.0 mOhms -----0 Points ----- Minor
 - +10.1 to +15.0 mOhms -----0 Points ----- Acceptable
 - +15.1 to +50.0 mOhms -----0 Points ----- Marginal
 - +50.1 to +1000 mOhms-----0 Points ----- Unstable
 - >+1000 mOhms-----0 Points ----- Open Failure
- **Thermal Shock**
 - <= +5.0 mOhms----- 48 Points ----- Stable
 - +5.1 to +10.0 mOhms -----0 Points ----- Minor
 - +10.1 to +15.0 mOhms -----0 Points ----- Acceptable
 - +15.1 to +50.0 mOhms -----0 Points ----- Marginal
 - +50.1 to +1000 mOhms-----0 Points ----- Unstable
 - >+1000 mOhms-----0 Points ----- Open Failure
- **Humidity**
 - <= +5.0 mOhms----- 48 Points ----- Stable
 - +5.1 to +10.0 mOhms -----0 Points ----- Minor
 - +10.1 to +15.0 mOhms -----0 Points ----- Acceptable
 - +15.1 to +50.0 mOhms -----0 Points ----- Marginal
 - +50.1 to +1000 mOhms-----0 Points ----- Unstable
 - >+1000 mOhms-----0 Points ----- Open Failure

RESULTS Continued**LLCR Shock & Vibration (144 signal and 48 ground LLCR test points)****Signal pin**

- **Initial** ----- 376.78 mOhms Max
- **Shock & Vibration**
 - <= +5.0 mOhms ----- 118 Points ----- Stable
 - +5.1 to +10.0 mOhms ----- 21 Points ----- Minor
 - +10.1 to +15.0 mOhms ----- 5 Points ----- Acceptable
 - +15.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +1000 mOhms ----- 0 Points ----- Unstable
 - >+1000 mOhms ----- 0 Points ----- Open Failure

Ground pin

- **Initial** ----- 37.65 mOhms Max
- **Shock & Vibration**
 - <= +5.0 mOhms ----- 42 Points ----- Stable
 - +5.1 to +10.0 mOhms ----- 6 Points ----- Minor
 - +10.1 to +15.0 mOhms ----- 0 Points ----- Acceptable
 - +15.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +1000 mOhms ----- 0 Points ----- Unstable
 - >+1000 mOhms ----- 0 Points ----- Open Failure

Mechanical Shock & Random Vibration:

- **Shock**
 - **No Damage** ----- Pass
 - **50 Nanoseconds** ----- Pass
- **Vibration**
 - **No Damage** ----- Pass
 - **50 Nanoseconds** ----- Pass

DATA SUMMARIES

TEMPERATURE RISE (Current Carrying Capacity, CCC):

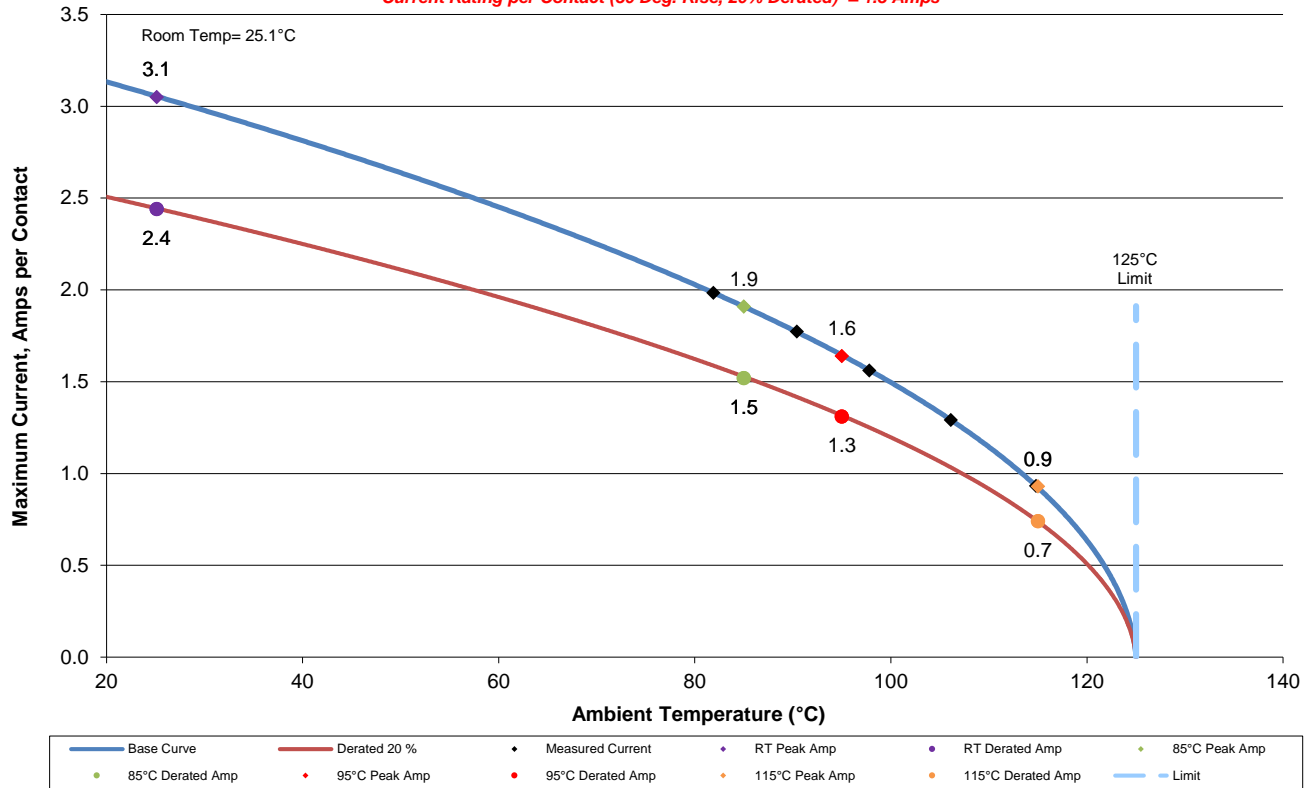
- 1) High quality thermocouples whose temperature slopes track one another were used for temperature monitoring.
- 2) The thermocouples were placed at a location to sense the maximum temperature generated during testing.
- 3) Temperature readings recorded are those for which three successive readings, 15 minutes apart, differ less than 1° C (computer-controlled data acquisition).
- 4) Adjacent contacts were powered:

Signal Pin

- a. Linear configuration with 6 adjacent conductors/contacts powered

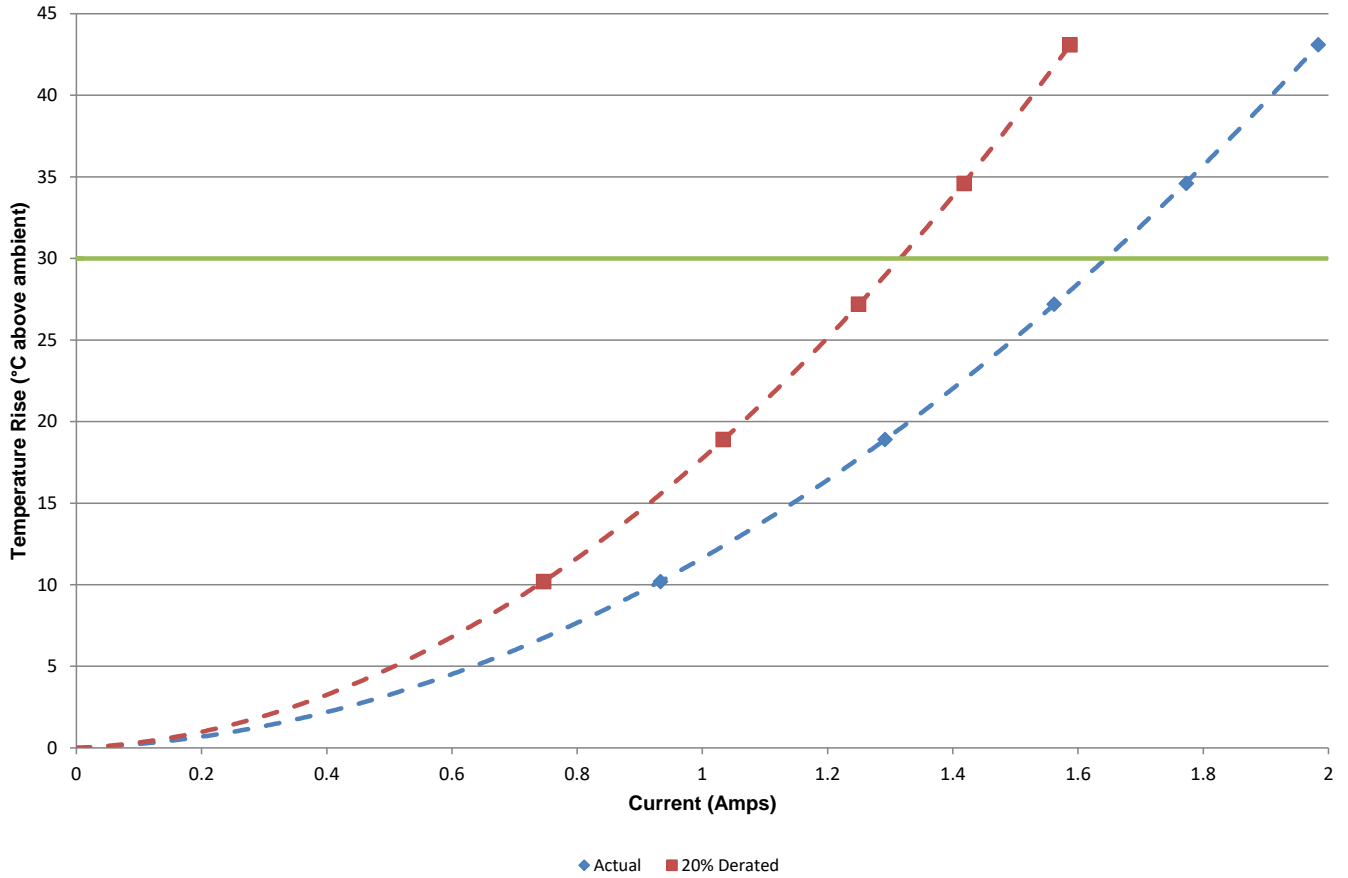
3411480
 6(6X1) Contacts in Series(Contact Interface)
 Part Numbers:ARP6-DP-012-06-12.0-B-L-L/APF6-037-03.5-L-06-2-L-TR

Current Rating per Contact (30 Deg. Rise, 20% Derated) = 1.3 Amps



DATA SUMMARIES Continued

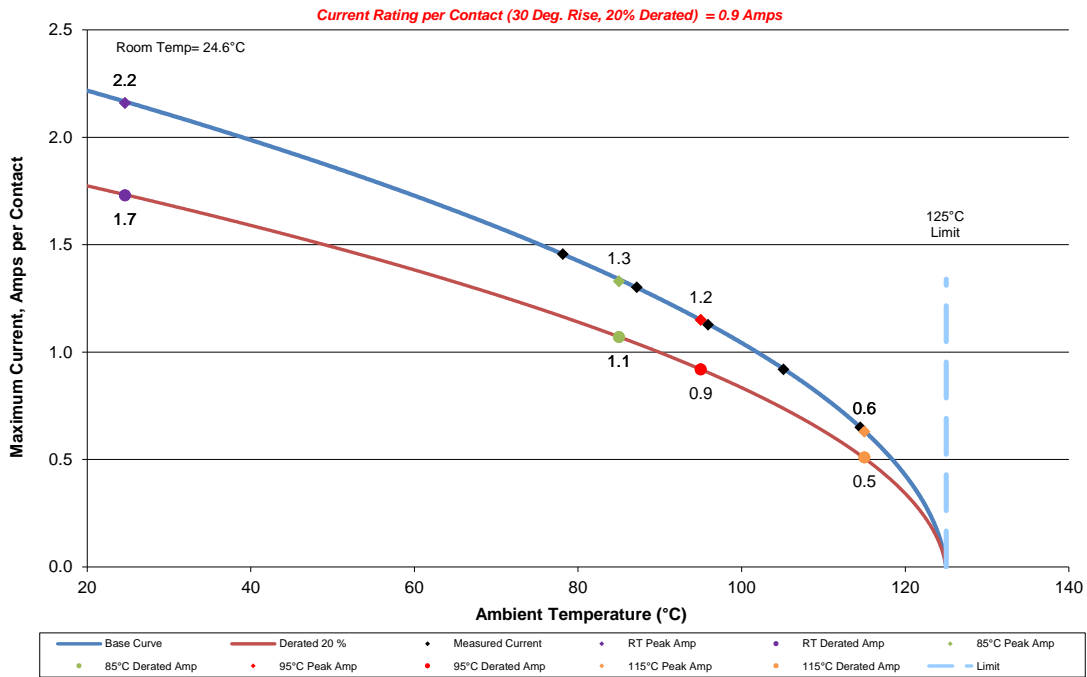
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6(6X1) Contacts in Series(Contact Interface)
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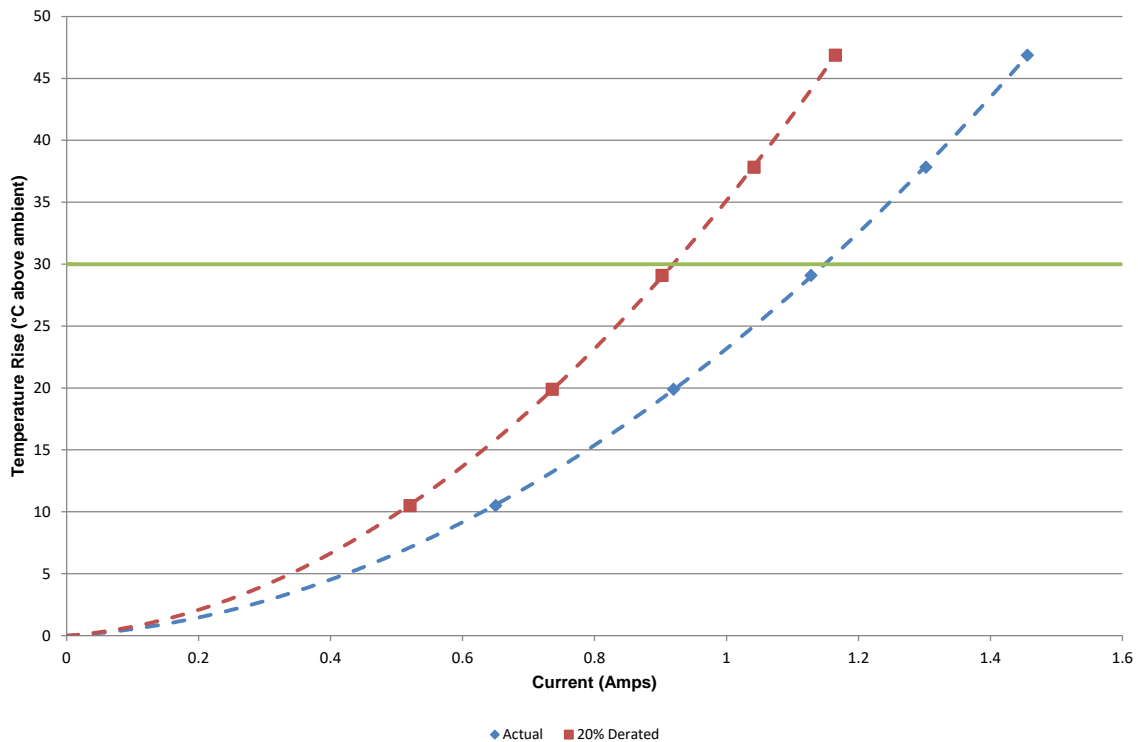
DATA SUMMARIES Continued

b. Linear configuration with 12 adjacent conductors/contacts powered

3411480
 12(6X2) Contacts in Series(Contact Interface)
 Part Numbers:ARP6-DP-012-06-12.0-B-L-L/APF6-037-03.5-L-06-2-L-TR



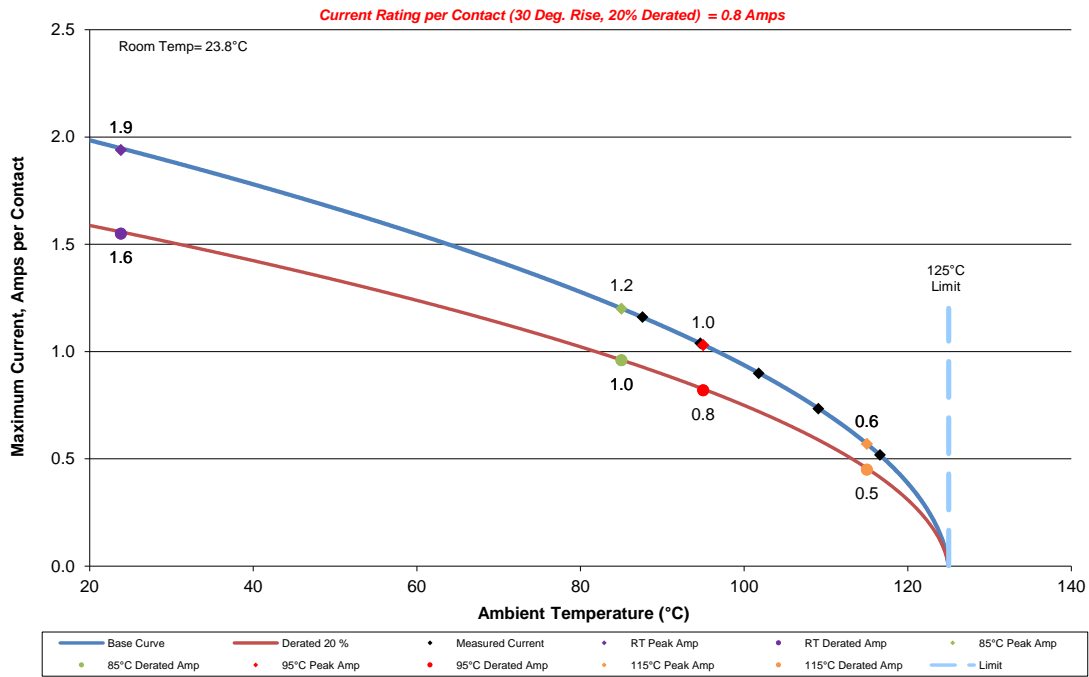
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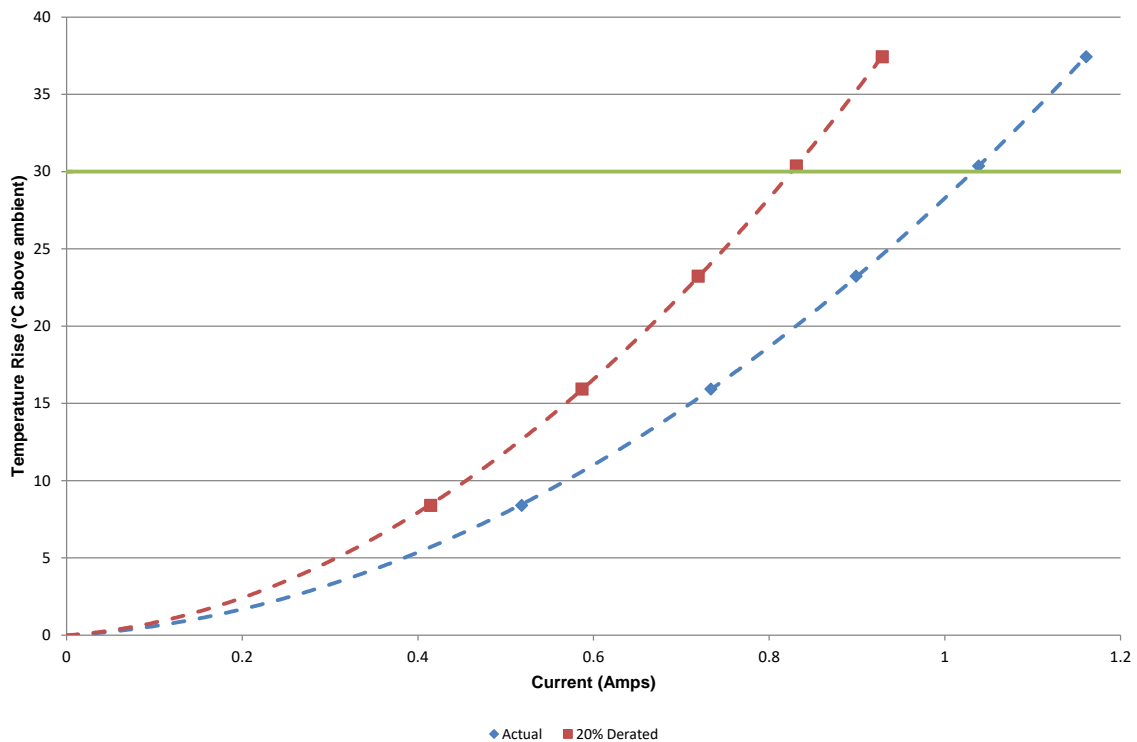
DATA SUMMARIES Continued

c. Linear configuration with 18 adjacent conductors/contacts powered

3411480
 18(6X3) Contacts in Series(Contact Interface)
 Part Numbers:ARP6-DP-012-06-12.0-B-L-L/APF6-037-03.5-L-06-2-L-TR



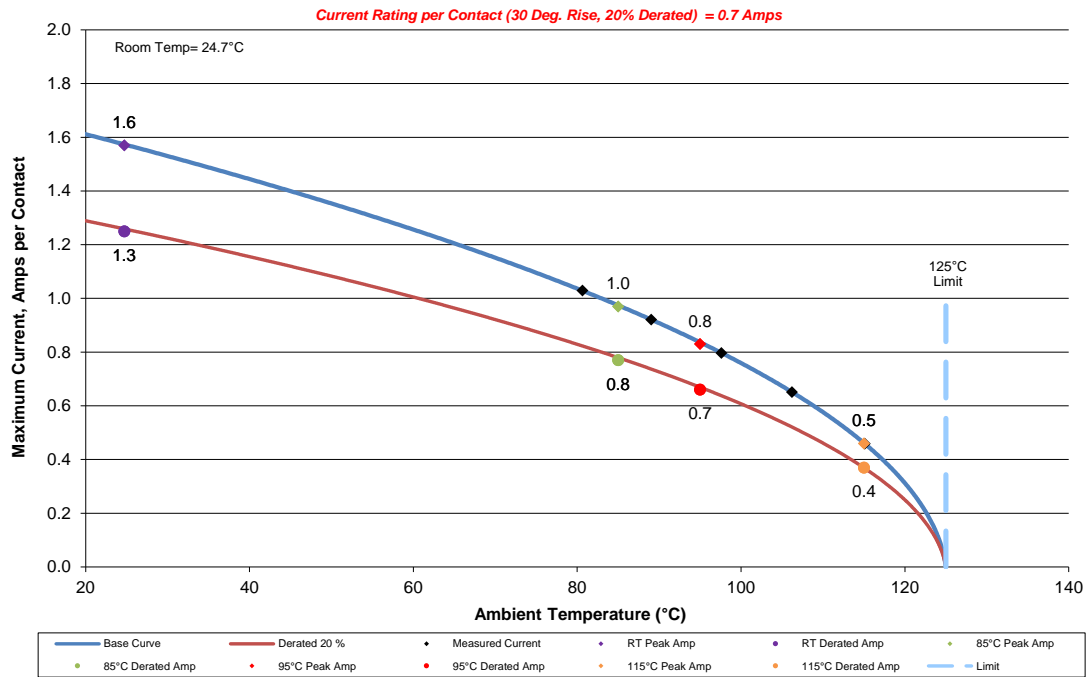
3411480
 18(6X3) Contacts in Series(Contact Interface)
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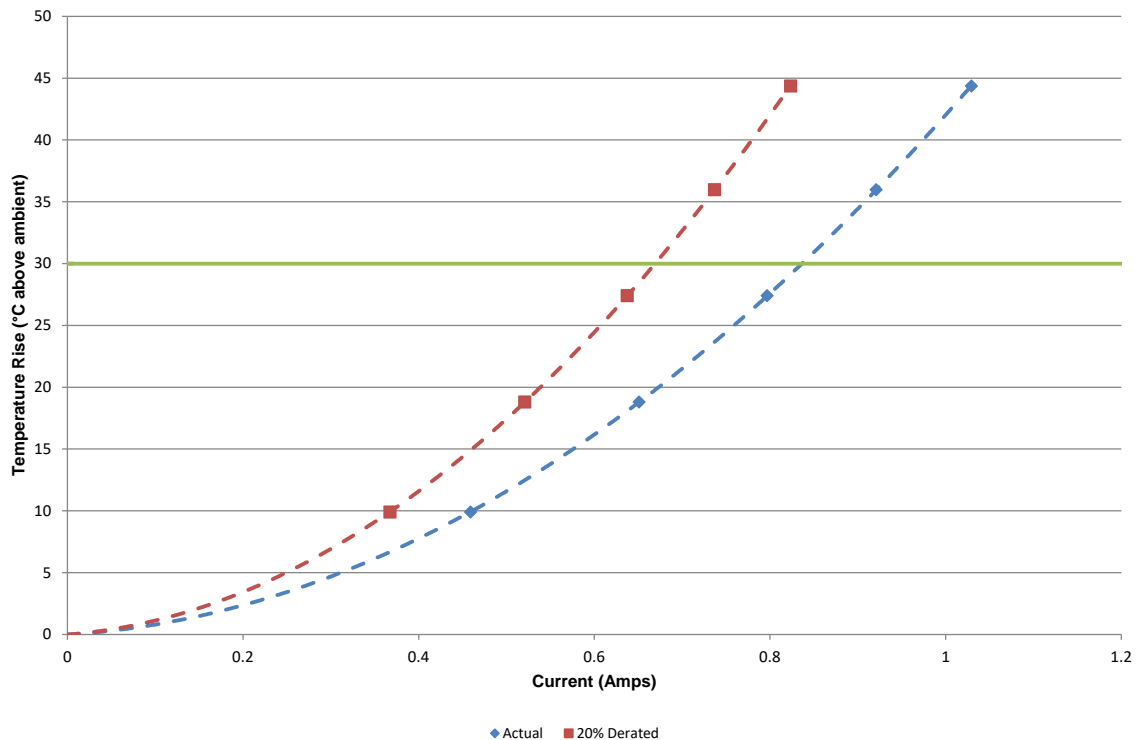
DATA SUMMARIES Continued

d. Linear configuration with 24 adjacent conductors/contacts powered

3411480
 24(6X4) Contacts in Series(Contact Interface)
 Part Numbers:ARP6-DP-012-06-12.0-B-L-L/APF6-037-03.5-L-06-2-L-TR



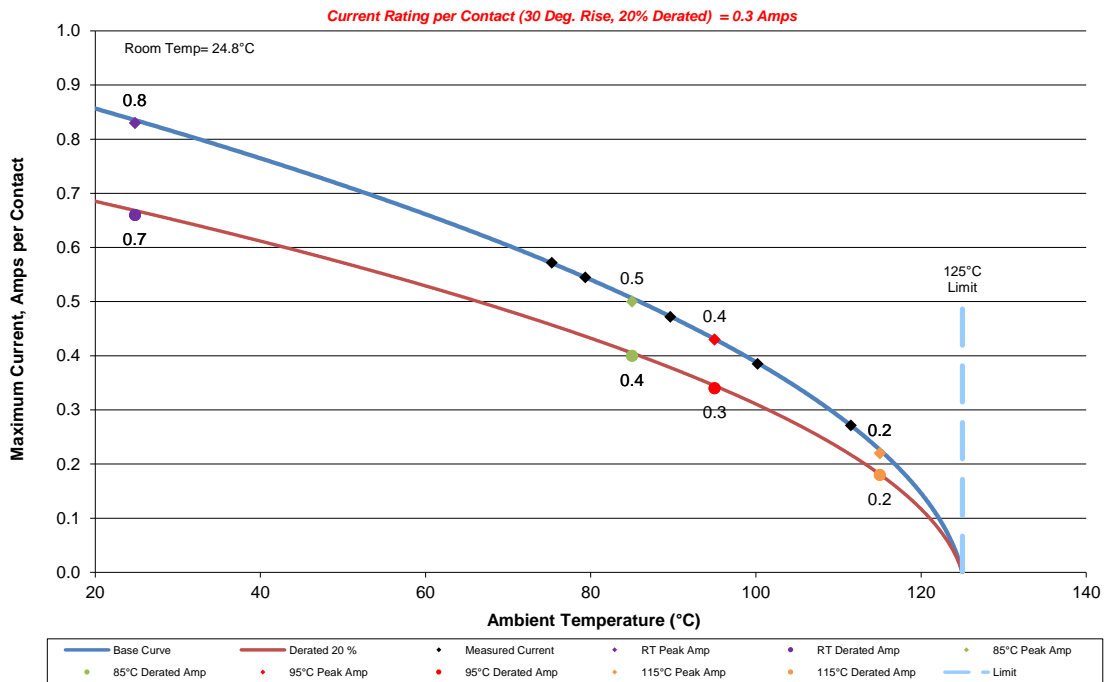
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 24(6X4) Contacts in Series(Contact Interface)
 Part Numbers:ARP6-DP-012-06-12.0-B-L-L/APF6-037-03.5-L-06-2-L-TR



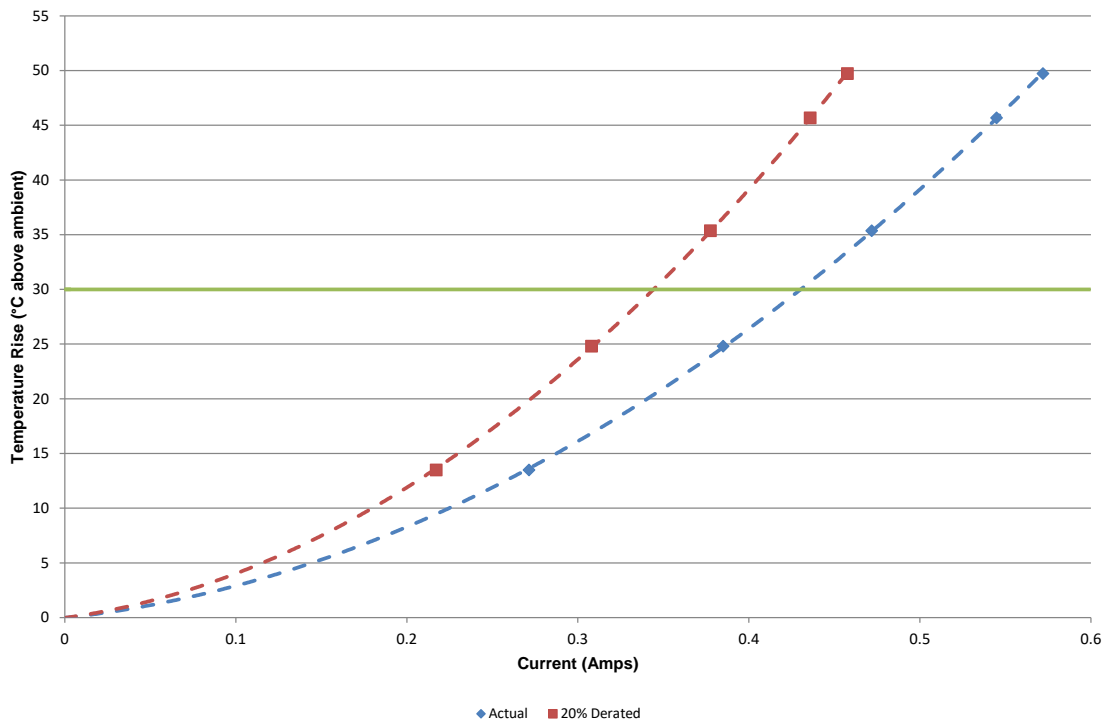
DATA SUMMARIES Continued

e. Linear configuration with all adjacent conductors/contacts powered

3411480
 144(6X24) Contacts in Series(Contact Interface)
 Part Numbers:ARP6-DP-012-06-12.0-B-L-L/APF6-037-03.5-L-06-2-L-TR



3411480
 144(6X24) Contacts in Series(Contact Interface)
 Part Numbers:ARP6-DP-012-06-12.0-B-L-L/APF6-037-03.5-L-06-2-L-TR

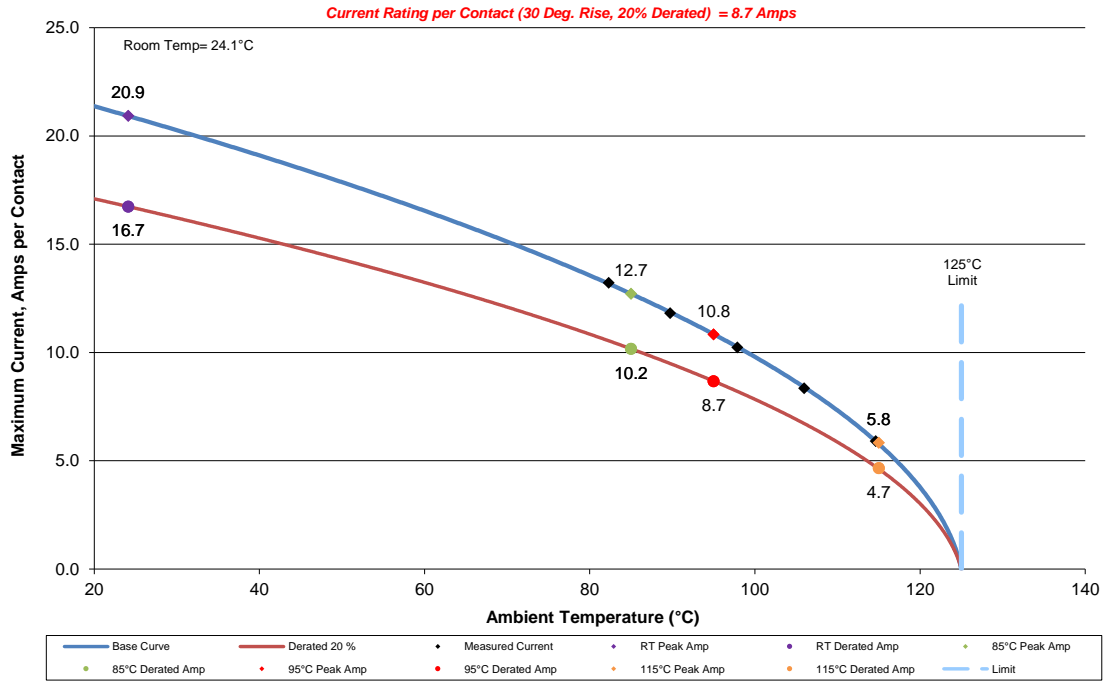


DATA SUMMARIES Continued

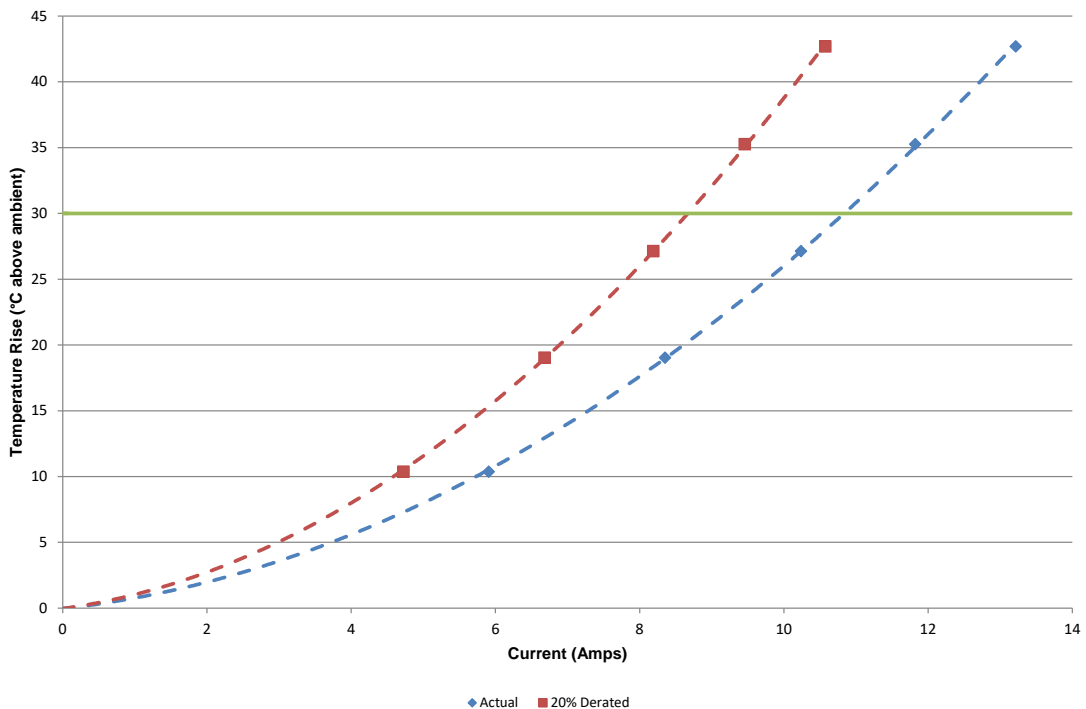
Ground Pin

f. Linear configuration with all adjacent conductors/contacts powered

3411480
 6(6X1) Contacts in Series(Contact Interface)
 Part Numbers:ARP6-DP-012-06-12.0-B-L-L/APF6-037-03.5-L-06-2-L-TR



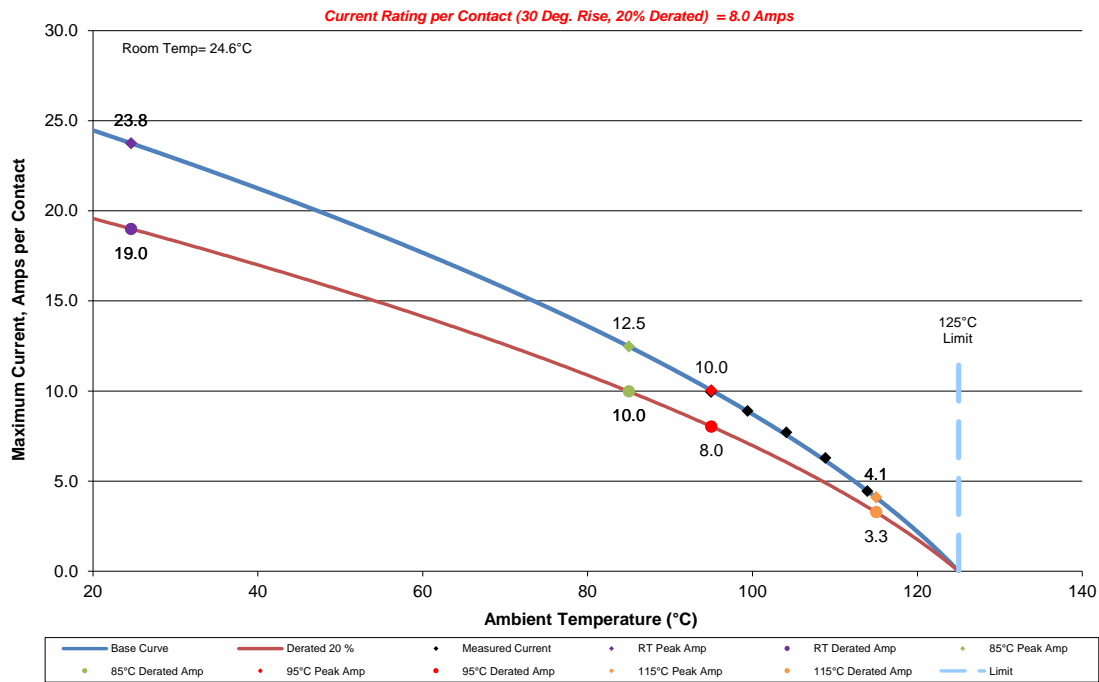
3411480
 6(6X1) Contacts in Series(Contact Interface)
 Part Numbers:ARP6-DP-012-06-12.0-B-L-L/APF6-037-03.5-L-06-2-L-TR



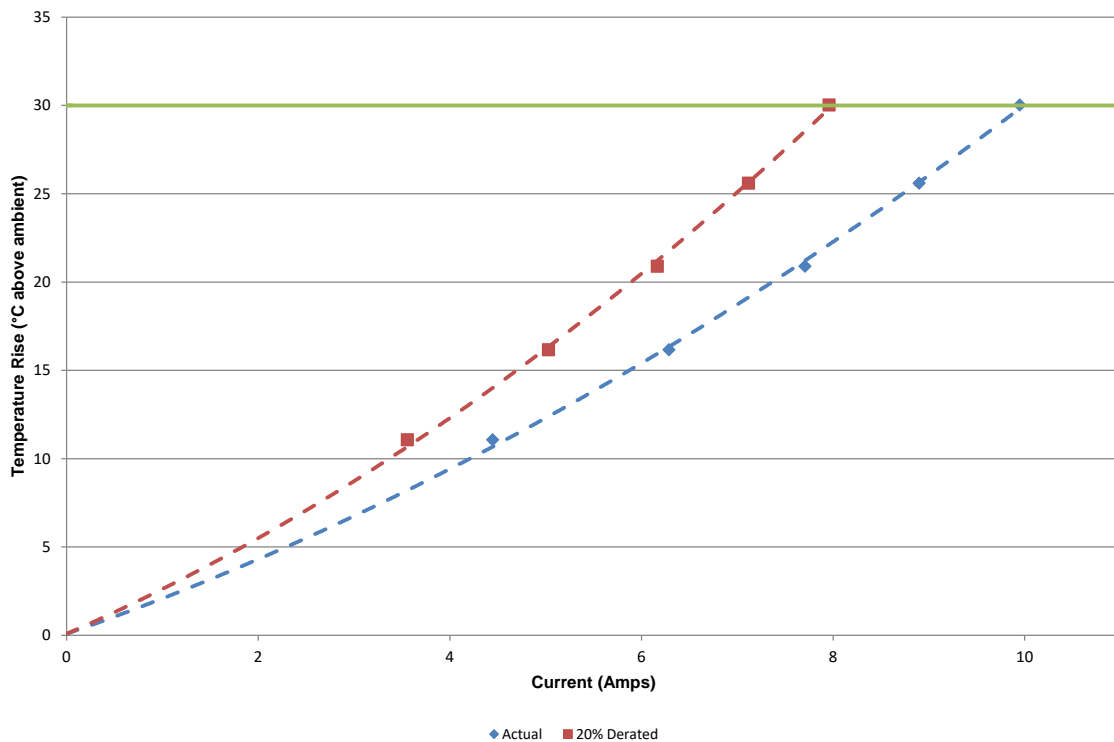
DATA SUMMARIES Continued

g. Linear configuration with all adjacent conductors/contacts powered

3411480
 6(6X1) Contacts in Series(Grounds)(Signals Powered at 1/2 Rated Current)(Contact Interface)
 Part Numbers:ARP6-DP-012-06-12.0-B-L-L/APF6-037-03.5-L-06-2-L-TR



3411480
 6(6X1) Contacts in Series(Grounds)(Signals Powered at 1/2 Rated Current)(Contact Interface)
 Part Numbers:ARP6-DP-012-06-12.0-B-L-L/APF6-037-03.5-L-06-2-L-TR



DATA SUMMARIES Continued**MATING-UNMATING FORCE:****Thermal Aging Group**

	Initial				After Thermals			
	Mating		Unmating		Mating		Unmating	
	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)
Minimum	52.22	11.74	24.95	5.61	33.85	7.61	24.38	5.48
Maximum	60.27	13.55	29.62	6.66	36.70	8.25	28.65	6.44
Average	55.70	12.52	27.06	6.08	35.66	8.02	26.27	5.91
St Dev	2.74	0.62	1.38	0.31	1.03	0.23	1.57	0.35
Count	8	8	8	8	8	8	8	8

Mating-Unmating Durability Group (Largest Pin Count)

	Initial				After 25 Cycles			
	Mating		Unmating		Mating		Unmating	
	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)
Minimum	46.97	10.56	20.95	4.71	46.79	10.52	23.22	5.22
Maximum	54.00	12.14	29.40	6.61	55.02	12.37	32.56	7.32
Average	50.41	11.33	25.50	5.73	51.54	11.59	28.77	6.47
St Dev	2.51	0.56	2.94	0.66	3.26	0.73	3.15	0.71
Count	8	8	8	8	8	8	8	8

	After 50 Cycles				After 75 Cycles			
	Mating		Unmating		Mating		Unmating	
	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)
Minimum	47.50	10.68	25.44	5.72	47.86	10.76	27.62	6.21
Maximum	54.58	12.27	35.09	7.89	54.40	12.23	36.47	8.20
Average	51.70	11.62	31.19	7.01	51.98	11.69	32.94	7.41
St Dev	2.86	0.64	3.27	0.73	2.73	0.61	3.18	0.72
Count	8	8	8	8	8	8	8	8

	After 100 Cycles				After Humidity			
	Mating		Unmating		Mating		Unmating	
	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)
Minimum	48.39	10.88	28.96	6.51	36.87	8.29	21.53	4.84
Maximum	54.58	12.27	36.92	8.30	44.12	9.92	31.14	7.00
Average	52.10	11.71	34.07	7.66	40.80	9.17	26.49	5.96
St Dev	2.53	0.57	3.03	0.68	2.37	0.53	3.44	0.77
Count	8	8	8	8	8	8	8	8

DATA SUMMARIES Continued**Mating-Unmating Basic (Smallest Pin Count)**

	Initial				25 Cycles			
	Mating		Unmating		Mating		Unmating	
	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)
Minimum	22.77	5.12	11.08	2.49	24.20	5.44	12.54	2.82
Maximum	25.62	5.76	13.57	3.05	27.71	6.23	15.66	3.52
Average	24.30	5.46	12.10	2.72	25.53	5.74	13.77	3.10
St Dev	0.99	0.22	0.93	0.21	1.39	0.31	1.03	0.23
Count	8	8	8	8	8	8	8	8
	50 Cycles				75 Cycles			
	Mating		Unmating		Mating		Unmating	
	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)
Minimum	24.20	5.44	14.10	3.17	24.46	5.50	14.99	3.37
Maximum	27.98	6.29	17.12	3.85	28.42	6.39	18.10	4.07
Average	25.54	5.74	15.07	3.39	25.72	5.78	16.13	3.63
St Dev	1.52	0.34	1.03	0.23	1.56	0.35	0.98	0.22
Count	8	8	8	8	8	8	8	8
	100 Cycles							
	Mating		Unmating					
	Newton's	Force (Lbs)	Newton's	Force (Lbs)				
Minimum	24.51	5.51	13.88	3.12				
Maximum	28.65	6.44	18.99	4.27				
Average	25.97	5.84	16.54	3.72				
St Dev	1.55	0.35	1.49	0.33				
Count	8	8	8	8				

DATA SUMMARIES Continued

NORMAL FORCE (FOR CONTACTS TESTED IN THE HOUSING):

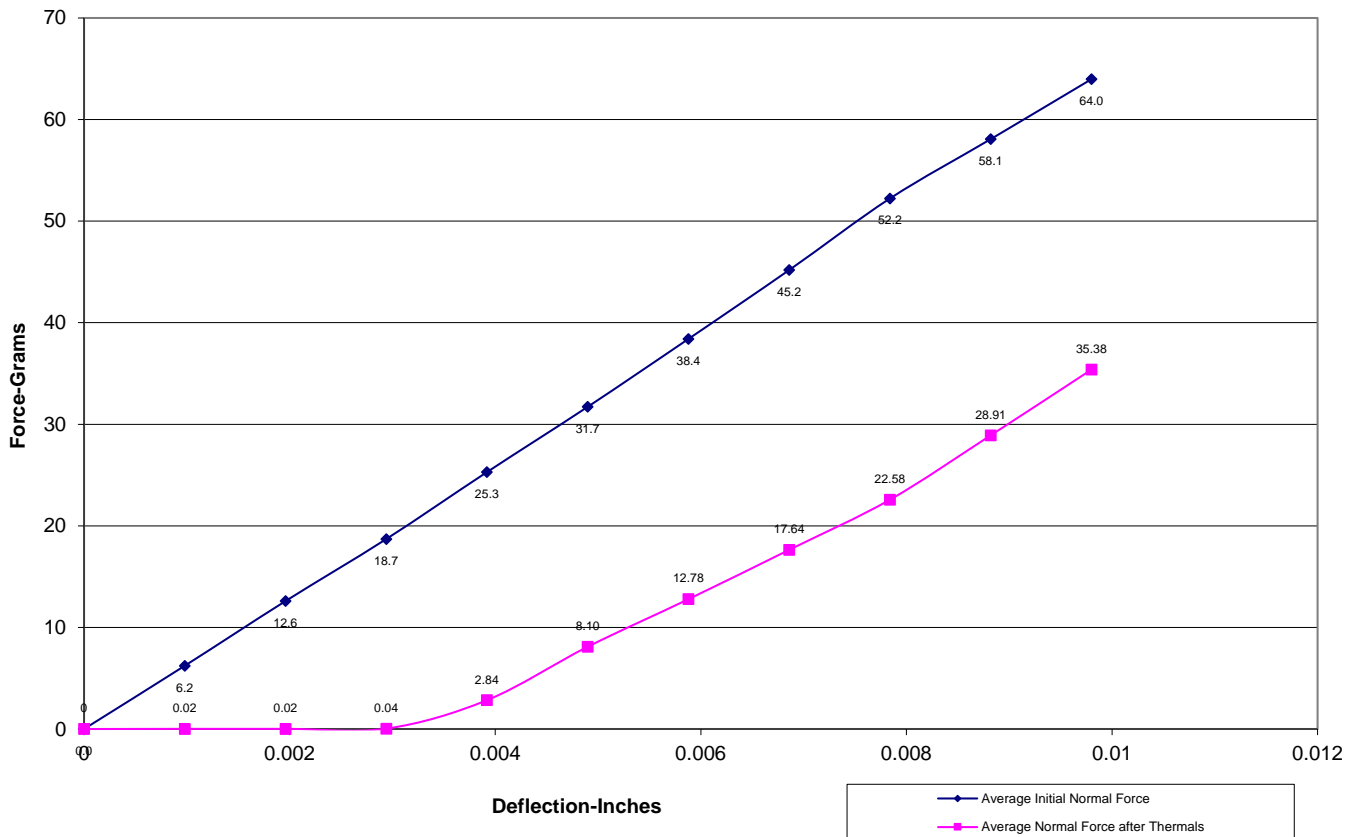
- 1) Calibrated force gauges are used along with computer-controlled positioning equipment.
- 2) For Normal force 8-10 measurements are taken and the averages reported.

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Initial	Deflections in inches Forces in Grams										
	0.0010	0.0020	0.0029	0.0039	0.0049	0.0059	0.0069	0.0078	0.0088	0.0098	SET
Averages	6.23	12.59	18.70	25.29	31.72	38.40	45.18	52.23	58.07	63.97	0.0008
Min	5.70	11.70	17.00	22.80	29.20	35.80	43.00	50.40	56.50	62.60	0.0007
Max	7.40	13.30	20.80	27.30	33.90	40.70	47.10	54.40	59.80	65.60	0.0009
St. Dev	0.433	0.509	1.035	1.215	1.512	1.368	1.174	1.031	0.947	0.888	0.0001
Count	12	12	12	12	12	12	12	12	12	12	12

After Thermals	Deflections in inches Forces in Grams										
	0.0010	0.0020	0.0029	0.0039	0.0049	0.0059	0.0069	0.0078	0.0088	0.0098	SET
Averages	0.02	0.02	0.04	2.84	8.10	12.78	17.64	22.58	28.91	35.38	0.0032
Min	-0.30	-0.30	-0.30	0.10	5.80	10.70	15.40	20.00	24.90	31.20	0.0029
Max	0.10	0.20	0.20	4.80	9.90	14.60	19.30	24.20	31.40	38.10	0.0035
St. Dev	0.153	0.175	0.173	1.301	1.076	1.109	1.089	1.177	1.953	1.975	0.0002
Count	12	12	12	12	12	12	12	12	12	12	12

Normal Force - Average Initial vs Average Thermal



DATA SUMMARIES Continued

NORMAL FORCE (FOR CONTACTS TESTED IN THE HOUSING):

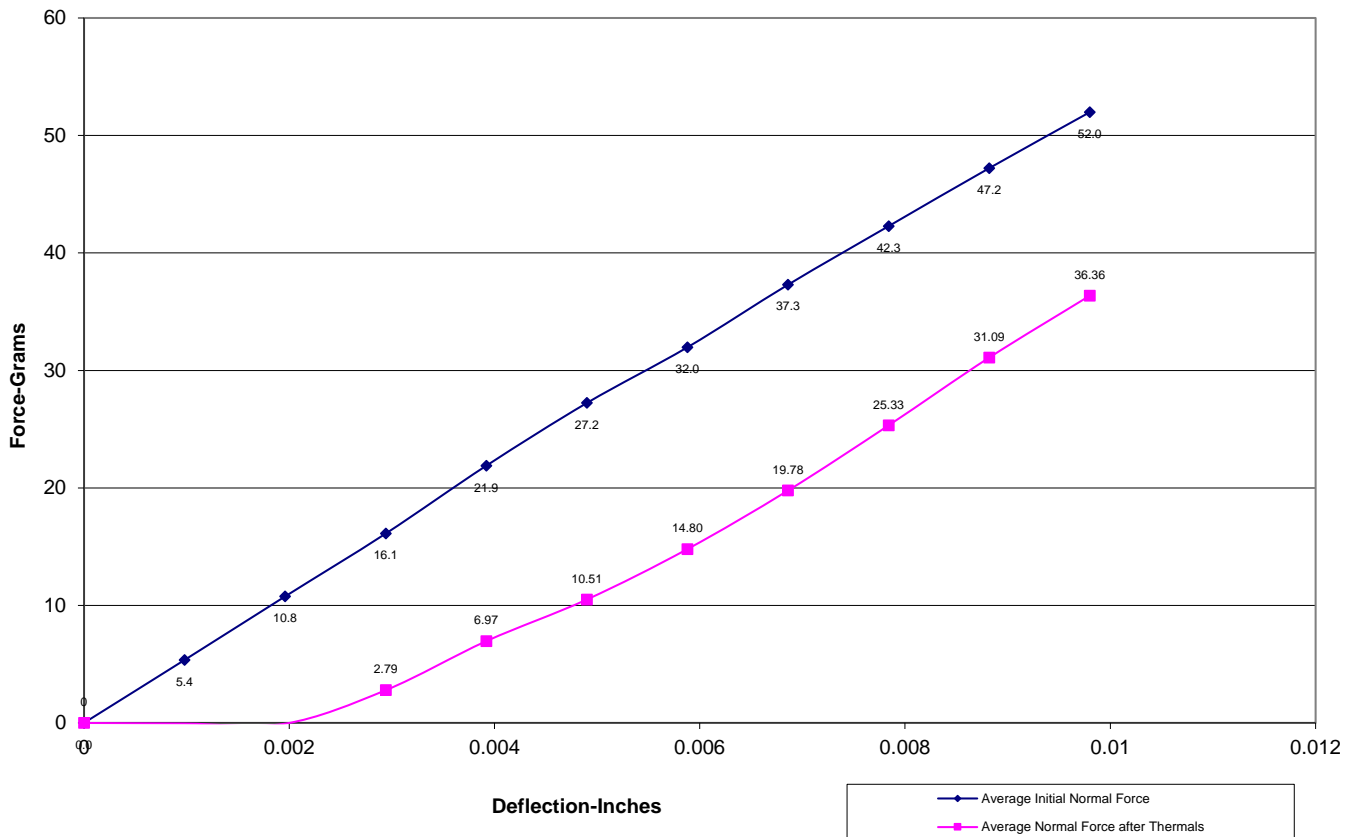
- 1) Calibrated force gauges are used along with computer-controlled positioning equipment.
- 2) For Normal force 8-10 measurements are taken and the averages reported.

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Initial	Deflections in inches Forces in Grams										
	0.0010	0.0020	0.0029	0.0039	0.0049	0.0059	0.0069	0.0078	0.0088	0.0098	SET
Averages	5.36	10.77	16.12	21.89	27.23	31.98	37.30	42.28	47.22	51.98	0.0006
Min	4.70	9.80	14.70	20.10	25.30	29.70	34.80	39.80	44.50	49.20	0.0002
Max	6.10	12.20	17.70	23.90	29.20	34.20	39.50	44.30	49.00	54.00	0.0009
St. Dev	0.423	0.824	0.991	1.246	1.272	1.718	1.629	1.480	1.457	1.576	0.0002
Count	12	12	12	12	12	12	12	12	12	12	12

After Thermals	Deflections in inches Forces in Grams										
	0.0010	0.0020	0.0029	0.0039	0.0049	0.0059	0.0069	0.0078	0.0088	0.0098	SET
Averages	-0.05	-0.06	2.79	6.97	10.51	14.80	19.78	25.33	31.09	36.36	0.0022
Min	-0.60	-0.70	0.60	5.70	8.90	11.60	16.20	21.50	27.40	32.80	0.0018
Max	0.40	0.40	4.10	7.80	11.70	16.50	21.70	27.70	33.10	39.10	0.0025
St. Dev	0.288	0.303	0.929	0.629	0.844	1.419	1.610	1.927	1.659	1.715	0.0002
Count	12	12	12	12	12	12	12	12	12	12	12

Normal Force - Average Initial vs Average Thermal



DATA SUMMARIES Continued**Cable Pull Force:
Smallest Pin Count
0° Pull**

	Force (lbs)
Minimum	52.20
Maximum	58.76
Average	56.58

90° Pull

	Force (lbs)
Minimum	28.67
Maximum	33.53
Average	31.50

**Largest Pin Count
0° Pull**

	Force (lbs)
Minimum	41.67
Maximum	44.11
Average	43.41

90° Pull

	Force (lbs)
Minimum	43.09
Maximum	45.78
Average	44.10

DATA SUMMARIES Continued**INSULATION RESISTANCE (IR):**

	Pin to Pin		
	Mated	Unmated	Unmated
Minimum	HDR/APF6	HDR	APF6
Initial	45000	45000	45000
Thermal	45000	45000	45000
Humidity	45000	45000	45000

	Row to Row		
	Mated	Unmated	Unmated
Minimum	HDR/APF6	HDR	APF6
Initial	45000	45000	45000
Thermal	45000	45000	45000
Humidity	45000	45000	45000

	Pin to Ground		
	Mated	Unmated	Unmated
Minimum	HDR/APF6	HDR	APF6
Initial	45000	45000	45000
Thermal	45000	45000	45000
Humidity	45000	45000	45000

	Pin to Closest Metallic Hardware		
	Mated	Unmated	Unmated
Minimum	HDR/APF6	HDR	APF6
Initial	45000	45000	45000
Thermal	45000	45000	45000
Humidity	45000	45000	45000

DATA SUMMARIES Continued**DIELECTRIC WITHSTANDING VOLTAGE (DWV):**

Voltage Rating Summary	
Minimum	HDR/APF6
Break Down Voltage	658
Test Voltage	495
Working Voltage	165

Pin to Pin	
Initial Test Voltage	Passed
After Thermal Test Voltage	Passed
After Humidity Test Voltage	Passed

Row to Row	
Initial Test Voltage	Passed
After Thermal Test Voltage	Passed
After Humidity Test Voltage	Passed

Pin to Ground	
Initial Test Voltage	Passed
After Thermal Test Voltage	Passed
After Humidity Test Voltage	Passed

Pin to Closest Metallic Hardware	
Initial Test Voltage	Passed
After Thermal Test Voltage	Passed
After Humidity Test Voltage	Passed

DATA SUMMARIES Continued**Cable Flex:****Insulation Resistance minimums, IR
Smallest Pin Count**

Pin to Pin	
Mated	
Minimum	
Initial	45000
After 500 Flex Cycles	45000

Row to Row	
Mated	
Minimum	
Initial	45000
After 500 Flex Cycles	45000

Pin to Ground	
Mated	
Minimum	
Initial	45000
After 500 Flex Cycles	45000

Pin to Closest Metallic Hardware	
Mated	
Minimum	
Initial	45000
After 500 Flex Cycles	45000

DATA SUMMARIES Continued**Largest Pin Count**

Pin to Pin	
Mated	
Minimum	
Initial	45000
After 500 Flex Cycles	45000

Row to Row	
Mated	
Minimum	
Initial	45000
After 500 Flex Cycles	45000

Pin to Ground	
Mated	
Minimum	
Initial	35000
After 500 Flex Cycles	44000

Pin to Closest Metallic Hardware	
Mated	
Minimum	
Initial	45000
After 500 Flex Cycles	45000

DATA SUMMARIES Continued**Dielectric Withstanding Voltage minimums, DWV**

Voltage Rating Summary	
Minimum	HDR/APF6
Test Voltage	495

Smallest Pin Count

Pin to Pin	
Initial Test Voltage	Passed
After 500 Flex Cycles Test Voltage	Passed

Row to Row	
Initial Test Voltage	Passed
After 500 Flex Cycles Test Voltage	Passed

Pin to Ground	
Initial Test Voltage	Passed
After 500 Flex Cycles Test Voltage	Passed

Pin to Closest Metallic Hardware	
Initial Test Voltage	Passed
After 500 Flex Cycles Test Voltage	Passed

Largest Pin Count

Pin to Pin	
Initial Test Voltage	Passed
After 500 Flex Cycles Test Voltage	Passed

Row to Row	
Initial Test Voltage	Passed
After 500 Flex Cycles Test Voltage	Passed

Pin to Ground	
Initial Test Voltage	Passed
After 500 Flex Cycles Test Voltage	Passed

Pin to Closest Metallic Hardware	
Initial Test Voltage	Passed
After 500 Flex Cycles Test Voltage	Passed

DATA SUMMARIES Continued

LLCR Gas Tight:

- 1) A total of 144 signal and 48 ground points were measured.
- 2) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 3) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 4) The following guidelines are used to categorize the changes in LLCR as a result from stressing.
 - a. $\leq +5.0$ mOhms:-----Stable
 - b. $+5.1$ to $+10.0$ mOhms:-----Minor
 - c. $+10.1$ to $+15.0$ mOhms:-----Acceptable
 - d. $+15.1$ to $+50.0$ mOhms:-----Marginal
 - e. $+50.1$ to $+1000$ mOhms:-----Unstable
 - f. $>+1000$ mOhms:-----Open Failure

LLCR Measurement Summaries by Pin Type				
Date	2022/8/11	2022/8/12		
Room Temp (Deg C)	22	22		
Rel Humidity (%)	52	52		
Technician	Kason He	Kason He		
mOhm values	Actual Initial	Delta Acid Vapor	Delta	Delta
Pin Type 1: Signal				
Average	352.74	4.00		
St. Dev.	8.14	3.97		
Min	331.71	0.00		
Max	380.10	14.80		
Summary Count	144	144		
Total Count	144	144		
Pin Type 2: Ground				
Average	21.82	0.48		
St. Dev.	2.10	0.38		
Min	19.89	0.01		
Max	26.97	1.51		
Summary Count	48	48		
Total Count	48	48		

LLCR Delta Count by Category						
	Stable	Minor	Acceptable	Marginal	Unstable	Open
mOhms	≤ 5	>5 & ≤ 10	>10 & ≤ 15	>15 & ≤ 50	>50 & ≤ 1000	>1000
Acid Vapor	144	34	14	0	0	0

DATA SUMMARIES Continued**LLCR Thermal Aging:**

- 1) A total of 144 signal and 48 ground points were measured.
- 2) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 3) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 4) The following guidelines are used to categorize the changes in LLCR as a result from stressing.
 - a. $\leq +5.0$ mOhms: -----Stable
 - b. $+5.1$ to $+10.0$ mOhms:-----Minor
 - c. $+10.1$ to $+15.0$ mOhms: -----Acceptable
 - d. $+15.1$ to $+50.0$ mOhms: -----Marginal
 - e. $+50.1$ to $+1000$ mOhms: -----Unstable
 - f. $>+1000$ mOhms:-----Open Failure

LLCR Measurement Summaries by Pin Type				
Date	2022/7/19	2022/8/1		
Room Temp (Deg C)	22	22		
Rel Humidity (%)	52	52		
Technician	Kason He	Kason He		
mOhm values	Actual Initial	Delta Thermal	Delta	Delta
Pin Type 1: Signal				
Average	352.88	3.61		
St. Dev.	16.40	2.40		
Min	337.53	0.35		
Max	473.40	13.10		
Summary Count	144	144		
Total Count	144	144		
Pin Type 2: Ground				
Average	21.22	0.96		
St. Dev.	2.28	0.41		
Min	19.17	0.13		
Max	26.82	1.93		
Summary Count	48	48		
Total Count	48	48		

LLCR Delta Count by Category						
	Stable	Minor	Acceptable	Marginal	Unstable	Open
mOhms	≤ 5	>5 & ≤ 10	>10 & ≤ 15	>15 & ≤ 50	>50 & ≤ 1000	>1000
Thermal	168	20	4	0	0	0

DATA SUMMARIES Continued

LLCR Mating/Unmating Durability Group

- 1). A total of 144 signal and 48 ground power points were measured.
- 2). EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 3). A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 4). The following guidelines are used to categorize the changes in LLCR as a result from stressing.
 - a. <= +5.0 mOhms:-----Stable
 - b. +5.1 to +10.0 mOhms:-----Minor
 - c. +10.1 to +15.0 mOhms:-----Acceptable
 - d. +15.1 to +50.0 mOhms:-----Marginal
 - e. +50.1 to +1000 mOhms:-----Unstable
 - f. >+1000 mOhms:-----Open Failure

LLCR Measurement Summaries by Pin Type				
Date	2022/7/19	2022/7/21	2022/7/26	2022/8/8
Room Temp (Deg C)	22	22	22	22
Rel Humidity (%)	52	50	52	52
Technician	Kason He	Kason He	Kason He	Kason He
mOhm values	Actual Initial	Delta 100 Cycles	Delta Therm Shck	Delta Humidity
Pin Type 1: Signal				
Average	352.80	2.43	1.61	2.57
St. Dev.	7.20	2.58	1.92	2.57
Min	338.80	0.00	0.00	0.10
Max	376.60	9.99	10.95	11.74
Summary Count	144	144	144	144
Total Count	144	144	144	144
Pin Type 2: Ground				
Average	21.94	0.40	0.53	0.50
St. Dev.	2.46	0.33	0.35	0.32
Min	19.62	0.01	0.01	0.00
Max	27.92	1.25	1.42	1.18
Summary Count	48	48	48	48
Total Count	48	48	48	48

LLCR Delta Count by Category						
mOhms	Stable	Minor	Acceptable	Marginal	Unstable	Open
	<=5	>5 & <=10	>10 & <=15	>15 & <=50	>50 & <=1000	>1000
100 Cycles	168	24	0	0	0	0
Therm Shck	183	7	2	0	0	0
Humidity	173	15	4	0	0	0

DATA SUMMARIES Continued

LLCR Shock & Vibration:

- 1). A total of 144 signal and 48 ground points were measured.
- 2). EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets.*
- 3). The following guidelines are used to categorize the changes in LLCR as a result from stressing.
 - a. $\leq +5.0$ mOhms: -----Stable
 - b. $+5.1$ to $+10.0$ mOhms: -----Minor
 - c. $+10.1$ to $+15.0$ mOhms: -----Acceptable
 - d. $+15.1$ to $+50.0$ mOhms: -----Marginal
 - e. $+50.1$ to $+1000$ mOhms -----Unstable
 - f. $>+1000$ mOhms:-----Open Failure

LLCR Measurement Summaries by Pin Type			
Date	2022/8/22	2022/8/26	
Room Temp (Deg C)	22	22	
Rel Humidity (%)	53	55	
Technician	Tony Wagoner	Tony Wagoner	
mOhm values	Actual	Delta	
	Initial	Shock-Vib	
Pin Type: Signal 1			
Average	351.44	2.53	
St. Dev.	8.41	2.91	
Min	330.38	0	
Max	376.78	11.54	
Summary Count	144	144	
Total Count	144	144	
Pin Type: GND 1			
Average	27.77	2.19	
St. Dev.	5.18	2.68	
Min	20.86	0.02	
Max	37.65	8.35	
Summary Count	48	48	
Total Count	48	48	

LLCR Delta Count by Category						
	Stable	Minor	Acceptable	Marginal	Unstable	Open
mOhms	≤ 5	$>5 \ \& \ \leq 10$	$>10 \ \& \ \leq 15$	$>15 \ \& \ \leq 50$	$>50 \ \& \ \leq 1000$	>1000
Shock-Vib	160	27	5	0	0	0

Nanosecond Event Detection:

Shock and Vibration Event Detection Summary	
Contacts tested	60
Test Condition	C, 100g's, 6ms, Half-Sine
Shock Events	0
Test Condition	V-B, 7.56 rms g
Vibration Events	0
Total Events	0

EQUIPMENT AND CALIBRATION SCHEDULES**Equipment #:** HZ-TCT-01**Description:** Normal force analyzer**Manufacturer:** Mecmesin Multitester**Model:** Mecmesin Multitester 2.5-i**Serial #:** 08-1049-04**Accuracy:** Last Cal: 3/5/2022, Next Cal: 3/4/2023**Equipment #:** DG-THC-01**Description:** Humidity transmitter**Manufacturer:** Thermtron**Model:** SM-8-8200**Serial #:** 50613**Accuracy:** Last Cal: 12/4/2021, Next Cal: 12/3/2022**Equipment #:** HZ-TSC-01**Description:** Vertical Thermal Shock Chamber**Manufacturer:** Cincinnatti Sub Zero**Model:** VTS-3-6-6-SC/AC**Serial #:** 10-VT14994**Accuracy:** See Manual

... Last Cal: 04/16/2022, Next Cal: 04/15/2023

Equipment #: DG-HPT-01**Description:** Hipot Safety Tester**Manufacturer:** Vitrek**Model:** V73**Serial #:** 025866**Accuracy:**

... Last Cal: 04/16/2022, Next Cal: 04/15/2023

Equipment #: HZ-MO-05**Description:** Micro-ohmmeter**Manufacturer:** Keithley**Model:** 3706**Serial #:** 1285188**Accuracy:** Last Cal: 1/2/2022, Next Cal: 1/1/2023**Equipment #:** HZ-MO-01**Description:** Micro-ohmmeter**Manufacturer:** Keithley**Model:** 2700**Serial #:** 1199807**Accuracy:** Last Cal: 05/19/2022, Next Cal: 05/18/2023**Equipment #:** HZ-PS-01**Description:** Power Supply**Manufacturer:** Agilent**Model:** 6031A**Serial #:** MY41000982**Accuracy:** Last Cal: 04/16/2022, Next Cal: 04/15/2023

EQUIPMENT AND CALIBRATION SCHEDULES**Equipment #:** SVC-01**Description:** Shock & Vibration Table**Manufacturer:** Data Physics**Model:** LE-DSA-10-20K**Serial #:** 10037**Accuracy:** See Manual

... Last Cal: 04/22/2022, Next Cal: 04/22/2023

Equipment #: ACLM-01**Description:** Accelerometer**Manufacturer:** PCB Piezotronics**Model:** 352C03**Serial #:** 115819**Accuracy:** See Manual

... Last Cal: 07/18/2022, Next Cal: 07/18/2023

Equipment #: ED-03**Description:** Event Detector**Manufacturer:** Analysis Tech**Model:** 32EHD**Serial #:** 1100604**Accuracy:** See Manual

... Last Cal: 10/31/2021, Next Cal: 10/31/2022